

## IN THE UNITED STATES ELECTED OFFICE (EO/US)

International Application No.	International Filing Date	Priority Date Claimed
PCT/US00/20748	31 July 2000	2 August 1999
<b>Title of Invention</b>		
CONTROLLED COMPLIANCE FINE PITCH INTERCONNECT		
<b>Applicant</b>		
Gryphics, Inc.		

Box PCT  
 Commissioner for Patents  
 Washington, D.C. 20231

EXPRESS MAIL LABEL NO. EL208608455US

JANUARY 16, 2002

ATTENTION: EO/US

**TRANSMITTAL LETTER TO THE UNITED STATES**  
**DESIGNATED/ELECTED OFFICE (DO/EO/US)**  
**CONCERNING A FILING UNDER 35 U.S.C. 371**

Applicant herewith submits to the United States Designated/Elected Office (DO/EO/US) the following items and other information:

1. This is a FIRST submission of items concerning a filing under 35 U.S.C. 371.
2. This express request to begin national examination procedures (35 U.S.C. 371(f)).
3. A copy of the International Application as filed (35 U.S.C. 371(c)(2)): is not required, as the application was filed in the United States Receiving Office (RO/US) on July 31, 2000.
4. Amendments to the claims of the International Application under PCT Article 19 (35 U.S.C. 371(c)(3)) are attached hereto in the Preliminary Amendment.
5. An oath or declaration of the inventor(s) (35 U.S.C. 371(c)(4)).
6. An Information Disclosure Statement under 37 CFR 1.97 and 1.98.
7. A FIRST Preliminary Amendment.

10/031422

JC13 Rec'd PCT/PTO 16 JAN 2002

Transmittal Letter ....Concerning A Filing Under 35 U.S.C. 371  
International Application No. PCT/US00/20748  
Page 2

8. A second copy of the published international application under 35 U.S.C.  
154(d)(4)

9. Other items or information:

Fee Calculation Page.

Credit Card Payment Form, PTO-2038, in the amount of \$1,304.00

Notification Of The Recording Of A Change

**CORRECT SPELLING OF APPLICANT'S NAME:**

Please note that the correct spelling of the applicant corporation is Gryphics,  
Inc., as indicated on the Notification of the Recording of a Change enclosed herewith.

In the event the amount submitted herewith is insufficient in any respect, the  
Commissioner is hereby authorized to charge the balance needed to our Deposit Account No.  
06-0029 and notify us of the same.

Respectfully Submitted,

JAMES J. RATHBURN

By:



Karl G. Schwappach, #35,786  
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Dated: January 16, 2002

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Attorney Docket No. 52191-243421

IN THE UNITED STATES ELECTED OFFICE (EO/US)

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**PRELIMINARY AMENDMENT**

After assigning a serial number and filing date to the U.S. national stage application based on the above-identified international application, but before calculating the total fee due for the filing of the application, please amend the application as follows:

**In the Claims:**

Please cancel claims 1-48 and replace them with the following new claims.

49 (New). An electrical connector for electrically interconnecting terminals on a flexible circuit member with terminals on a second circuit member, the electrical connector comprising:

a housing having a plurality of through holes extending between a first surface and a second surface, each of the through holes defining a central axis;

a plurality of elongated electrical contact members positioned in at least a portion of the through holes and oriented along the central axes, the electrical contact members having first ends extending above the first surface adapted to couple electrically with the terminals on the

flexible circuit member, and second ends extending above the second surface to couple electrically with the second circuit member; and

a resilient member comprises a compliant encapsulating material interposed between a portion of the through holes and a portion of the electrical contact members to control movement of the electrical contact members along their respective central axes.

50 (New). The electrical connector of claim 49 wherein first ends of the electrical contact members are attached to the terminals on the flexible circuit member.

51 (New). The electrical connector of claim 49 wherein the flexible circuit member comprises singulated terminals.

52 (New). The electrical connector of claim 49 wherein the resilient member further comprises a complaint material positioned along a surface of the flexible circuit member opposite the terminals of the flexible circuit member.

53 (New). The electrical connector of claim 52 further including a back-up member supporting the complaint material.

54 (New). The electrical connector of claim 49 wherein the second surface of the housing includes at least one device site corresponding to the second circuit member.

55 (New). The electrical connector of claim 49 wherein the second ends of the electrical contact members have a shape that corresponds to a shape of the terminals on the second circuit member.

56 (New). The electrical connector of claim 49 wherein the second ends of the electrical contact members are capable of engaging with a connector member selected from the

group consisting of a flexible circuit, a ribbon connector, a cable, a printed circuit board, a ball grid array (BGA), a land grid array (LGA), a plastic leaded chip carrier (PLCC), a pin grid array (PGA), a small outline integrated circuit (SOIC), a dual in-line package (DIP), a quad flat package (QFP), a leadless chip carrier (LCC), a chip scale package (CSP), or packaged or unpackaged integrated circuits.

57 (New). The electrical connector of claim 49 wherein the electrical contact members are one of a homogeneous material or a multi-layered construction.

58 (New). The electrical connector of claim 49 wherein the electrical contact members have a cross-sectional shape selected from one of circular, oval, polygonal, and rectangular.

59 (New). The electrical connector of claim 49 wherein a portion of the flexible circuit member is bonded to the first surface of the housing with an adhesive.

60 (New). The electrical connector of claim 49 wherein the electrical contact members are electrically coupled to the flex circuit using one or more of a compressive force, solder, a wedge bond, a conductive adhesive, an ultrasonic bond and a wire bond.

61 (New). The electrical connector of claim 49 wherein the second ends of at least two of the electrical contact members extend beyond the second surface of the housing by a different amount.

62 (New). The electrical connector of claim 49 wherein electrical contact members have a larger cross section proximate the first end than at the second end.

63 (New). The electrical connector of claim 49 wherein the plurality of through holes are arranged in a two-dimensional array.

64 (New). The electrical connector of claim 49 wherein the resilient member comprises a compliant encapsulating member elastically bonding the electrical contact members to the housing.

65 (New). An electrical connector for electrically interconnecting terminals on a flexible circuit member with terminals on a second circuit member, the electrical connector comprising:

a housing having a plurality of through holes extending between a first surface and a second surface, each of the through holes defining a central axis;

a plurality of elongated electrical contact members positioned in at least some of the through holes and oriented along the central axes, the electrical contact members having first ends extending above the first surface that are attached to, and electrically coupled with, the terminals on the flexible circuit member, the flexible circuit member controlling movement of the electrical contact members along their respective central axes, and second ends extending above the second surface to couple electrically with the second circuit member.

66 (New). The electrical connector of claim 65 wherein the flexible circuit member comprises singulated terminals.

67 (New). The electrical connector of claim 65 comprising a compliant material positioned along a surface of the flexible circuit member opposite the terminals of the flexible circuit member.

68 (New). The electrical connector of claim 65 comprising a compliant encapsulating member elastically bonding the electrical contact members to the housing.

69 (New). The electrical connector of claim 65 wherein the second surface of the housing includes at least one device site.

70 (New). The electrical connector of claim 65 wherein the second circuit member is one of a printed circuit board, a flexible circuit, a bare-die device, an integrated circuit device, an organic or inorganic substrate, a rigid circuit, or a wafer containing a plurality of integrated circuit devices.

71 (New). The electrical connector of claim 65 wherein the second ends of the electrical contact members comprises one or more of die level test probes, wafer probes, and printed circuit board probes.

72 (New). The electrical connector of claim 65 comprising a compliant encapsulating member elastically bonding the electrical contact members to the housing.

73 (New). The electrical connector of claim 65 wherein a portion of the flexible circuit member is bonded to the first surface of the housing with an adhesive.

74 (New). The electrical connector of claim 65 wherein the electrical contact members are electrically coupled to the flex circuit using one or more of compressive force, solder, a wedge bond, a conductive adhesive, an ultrasonic bond and a wire bond.

75 (New). The electrical connector of claim 65 wherein the first end of at least one of the electrical contact members extends through the flexible circuit member.

76 (New). The electrical connector of claim 65 wherein the flexible circuit member is folded over a resilient member to electrically couple two electrical interconnect assemblies in a stacked configuration.

77 (New). The electrical connector of claim 65 wherein the flexible circuit member comprises electrical contact pads along a second surface thereof.

78 (New). An electrical interconnect assembly using the electrical connector of claim 21 comprising:

a flexible circuit member having a plurality of terminals;

a first housing having a plurality of through holes extending between a first surface and a second surface, each of the through holes defining a central axis, a plurality of elongated electrical contact members positioned in at least some of the through holes and oriented along the central axes, the electrical contact members having first ends extending above the first surface that are attached to, and electrically coupled with, terminals on the flexible circuit member, the flexible circuit member controlling movement of the electrical contact members along their respective central axes, and second ends extending above the second surface to couple electrically with the second circuit member;

a second housing having a plurality of through holes extending between a first surface and a second surface, each of the through holes defining a central axis, a plurality of elongated electrical contact members positioned in at least some of the through holes and oriented along the central axes, the electrical contact members having first ends extending above the first surface and electrically coupled to terminals on the flexible circuit member, and second ends extending above the second surface to couple electrically with the third circuit member, the first surface of the first housing being positioned opposite the first surface of the second housing; and

a resilient member controlling movement of the electrical contact members in the second housing along their respective central axes.

79 (New). A method of making an electrical interconnect comprising the steps of: providing a housing with a plurality of through holes extending between a first surface and a second surface, each of the through holes defining a central axis;

positioning a plurality of elongated electrical contact members in at least some of the through holes oriented along the central axes, the electrical contact members having first ends extending above the first surface;

retaining the electrical contact members in the through holes; and

attaching and electrically coupling the first ends of the electrical contact members to the terminals on a flexible circuit member to control movement of the electrical contact members along their respective central axes and so that the second ends extending above the second surface.

80 (New). The method of claim 79 comprising the step of bonding the electrical contact members to the housing using a compliant material.

81 (New). The method of claim 79 comprising the step of singulating one or more of the terminals on the flexible circuit member.

82 (New). The method of claim 79 wherein the step of retaining the electrical contact members in the through holes comprises interposing a compliant encapsulating material between a portion of the through holes and a portion of the electrical contact members.

83 (New). The method of claim 79 wherein the step of retaining the electrical contact members in the through holes comprises surrounding a portion of the electrical contact members with a compliant encapsulating material along the first surface of the housing.

84 (New). The method of claim 79 wherein the step of retaining the electrical contact members in the through holes comprises positioning a compliant material along a surface of the flexible circuit member opposite the terminals.

85 (New). The method of claim 79 comprising positioning a compliant material along a surface of the flexible circuit member opposite the terminals.

86 (New). The method of claim 79 comprising the step of modifying the second ends of the electrical contact members to have a shape capable of engaging with a second circuit member selected from the group consisting of a flexible circuit, a ribbon connector, a cable, a printed circuit board, a ball grid array (BGA), a land grid array (LGA), a plastic lead chip carrier (PLCC), a pin grid array (PGA), a small outline integrated circuit (SOIC), a dual in-line package (DIP), a quad flat package (QFP), a leadless chip carrier (LCC), a chip scale package (CSP), packaged and unpackaged integrated circuits.

87 (New). The method of claim 79 wherein the electrical contact members are electrically coupled to the flex circuit using one or more of compressive forces, solder, wedge bonding, conductive adhesives, ultrasonic bonding and wire bonding.

88 (New). The method of claim 79 comprising the step of engaging the second ends of the electrical contact members with a second circuit member.

89 (New). The method of claim 79 comprising the step of preparing at least one device site on the second surface of the housing.

90 (New). A method of making an electrical interconnect for electrically coupling terminals on a flexible circuit member with terminals on a second circuit member, comprising the steps of:

providing a housing having a plurality of through holes extending between a first surface and a second surface, each of the through holes defining a central axis;

positioning a plurality of elongated electrical contact members in at least some of the through holes oriented along the central axes, the electrical contact members having first ends extending above the first surface; and

interposing a compliant encapsulating material between a portion of the through holes and a portion of the electrical contact members to control movement of the electrical contact members along their respective central axes.

**REMARKS**

Attached hereto is a marked-up version of the changes made to the specification, claims and abstract by the current amendment. The attached page is captioned "**Version With Markings To Show Changes Made**".

Respectfully Submitted,

JAMES J. RATHBURN

By:



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Dated: January 16, 2002

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**VERSION WITH MARKINGS TO SHOW CHANGES MADE**

**In The Claims**

Claims 1-48 have been cancelled.

Claim 49-90 have been added.

49 (New).     An electrical connector for electrically interconnecting terminals on a flexible circuit member with terminals on a second circuit member, the electrical connector comprising:

a housing having a plurality of through holes extending between a first surface and a second surface, each of the through holes defining a central axis;

a plurality of elongated electrical contact members positioned in at least a portion of the through holes and oriented along the central axes, the electrical contact members having first ends extending above the first surface adapted to couple electrically with the terminals on the flexible circuit member, and second ends extending above the second surface to couple electrically with the second circuit member; and

a resilient member comprises a compliant encapsulating material interposed between a portion of the through holes and a portion of the electrical contact members to control movement of the electrical contact members along their respective central axes.

50 (New).     The electrical connector of claim 49 wherein first ends of the electrical contact members are attached to the terminals on the flexible circuit member.

51 (New).     The electrical connector of claim 49 wherein the flexible circuit member comprises singulated terminals.

52 (New). The electrical connector of claim 49 wherein the resilient member further comprises a complaint material positioned along a surface of the flexible circuit member opposite the terminals of the flexible circuit member.

53 (New). The electrical connector of claim 52 further including a back-up member supporting the complaint material.

54 (New). The electrical connector of claim 49 wherein the second surface of the housing includes at least one device site corresponding to the second circuit member.

55 (New). The electrical connector of claim 49 wherein the second ends of the electrical contact members have a shape that corresponds to a shape of the terminals on the second circuit member.

56 (New). The electrical connector of claim 49 wherein the second ends of the electrical contact members are capable of engaging with a connector member selected from the group consisting of a flexible circuit, a ribbon connector, a cable, a printed circuit board, a ball grid array (BGA), a land grid array (LGA), a plastic leaded chip carrier (PLCC), a pin grid array (PGA), a small outline integrated circuit (SOIC), a dual in-line package (DIP), a quad flat package (QFP), a leadless chip carrier (LCC), a chip scale package (CSP), or packaged or unpackaged integrated circuits.

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58 (New). The electrical connector of claim 49 wherein the electrical contact members have a cross-sectional shape selected from one of circular, oval, polygonal, and rectangular.

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60 (New). The electrical connector of claim 49 wherein the electrical contact members are electrically coupled to the flex circuit using one or more of a compressive force, solder, a wedge bond, a conductive adhesive, an ultrasonic bond and a wire bond.

61 (New). The electrical connector of claim 49 wherein the second ends of at least two of the electrical contact members extend beyond the second surface of the housing by a different amount.

62 (New). The electrical connector of claim 49 wherein electrical contact members have a larger cross section proximate the first end than at the second end.

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a housing having a plurality of through holes extending between a first surface and a second surface, each of the through holes defining a central axis;

a plurality of elongated electrical contact members positioned in at least some of the through holes and oriented along the central axes, the electrical contact members having first ends extending above the first surface that are attached to, and electrically coupled with, the terminals on the flexible circuit member, the flexible circuit member controlling movement of the electrical contact members along their respective central axes, and second ends extending above the second surface to couple electrically with the second circuit member.

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76 (New). The electrical connector of claim 65 wherein the flexible circuit member is folded over a resilient member to electrically couple two electrical interconnect assemblies in a stacked configuration.

77 (New). The electrical connector of claim 65 wherein the flexible circuit member comprises electrical contact pads along a second surface thereof.

78 (New). An electrical interconnect assembly using the electrical connector of claim 21 comprising:

a flexible circuit member having a plurality of terminals;

a first housing having a plurality of through holes extending between a first surface and a second surface, each of the through holes defining a central axis, a plurality of elongated electrical contact members positioned in at least some of the through holes and oriented along the central axes, the electrical contact members having first ends extending above the first

surface that are attached to, and electrically coupled with, terminals on the flexible circuit member, the flexible circuit member controlling movement of the electrical contact members along their respective central axes, and second ends extending above the second surface to couple electrically with the second circuit member;

a second housing having a plurality of through holes extending between a first surface and a second surface, each of the through holes defining a central axis, a plurality of elongated electrical contact members positioned in at least some of the through holes and oriented along the central axes, the electrical contact members having first ends extending above the first surface and electrically coupled to terminals on the flexible circuit member, and second ends extending above the second surface to couple electrically with the third circuit member, the first surface of the first housing being positioned opposite the first surface of the second housing; and

a resilient member controlling movement of the electrical contact members in the second housing along their respective central axes.

79 (New). A method of making an electrical interconnect comprising the steps of: providing a housing with a plurality of through holes extending between a first surface and a second surface, each of the through holes defining a central axis;

positioning a plurality of elongated electrical contact members in at least some the through holes oriented along the central axes, the electrical contact members having first ends extending above the first surface;

retaining the electrical contact members in the through holes; and

attaching and electrically coupling the first ends of the electrical contact members to the terminals on a flexible circuit member to control movement of the electrical contact members along their respective central axes and so that the second ends extending above the second surface.

80 (New). The method of claim 79 comprising the step of bonding the electrical contact members to the housing using a compliant material.

81 (New). The method of claim 79 comprising the step of singulating one or more of the terminals on the flexible circuit member.

82 (New). The method of claim 79 wherein the step of retaining the electrical contact members in the through holes comprises interposing a compliant encapsulating material between a portion of the through holes and a portion of the electrical contact members.

83 (New). The method of claim 79 wherein the step of retaining the electrical contact members in the through holes comprises surrounding a portion of the electrical contact members with a compliant encapsulating material along the first surface of the housing.

84 (New). The method of claim 79 wherein the step of retaining the electrical contact members in the through holes comprises positioning a complaint material along a surface of the flexible circuit member opposite the terminals.

85 (New). The method of claim 79 comprising positioning a complaint material along a surface of the flexible circuit member opposite the terminals.

86 (New). The method of claim 79 comprising the step of modifying the second ends of the electrical contact members to have a shape capable of engaging with a second circuit member selected from the group consisting of a flexible circuit, a ribbon connector, a cable, a printed circuit board, a ball grid array (BGA), a land grid array (LGA), a plastic leaded chip carrier (PLCC), a pin grid array (PGA), a small outline integrated circuit (SOIC), a dual in-line package (DIP), a quad flat package (QFP), a leadless chip carrier (LCC), a chip scale package (CSP), packaged and unpackaged integrated circuits.

87 (New). The method of claim 79 wherein the electrical contact members are electrically coupled to the flex circuit using one or more of compressive forces, solder, wedge bonding, conductive adhesives, ultrasonic bonding and wire bonding.

88 (New). The method of claim 79 comprising the step of engaging the second ends of the electrical contact members with a second circuit member.

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90 (New). A method of making an electrical interconnect for electrically coupling terminals on a flexible circuit member with terminals on a second circuit member, comprising the steps of:

providing a housing having a plurality of through holes extending between a first surface and a second surface, each of the through holes defining a central axis;

positioning a plurality of elongated electrical contact members in at least some of the through holes oriented along the central axes, the electrical contact members having first ends extending above the first surface; and

interposing a compliant encapsulating material between a portion of the through holes and a portion of the electrical contact members to control movement of the electrical contact members along their respective central axes.

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**CONTROLLED COMPLIANCE FINE PITCH INTERCONNECT**

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Field of the Invention

The present invention is directed to a method and apparatus for achieving a very fine pitch, solderless interconnect between a flexible circuit member and another circuit member, and to an electrical interconnect assembly 10 for forming a solderless interconnection with another circuit member.

Background of the Invention

It is desirable to probe test each die or device under test (DUT) before the wafer is cut into individual integrated circuit die or before packaging. 15 Die testing often needs to be performed at high speed or high frequency, for example 100 MHz data rate or higher. The probe cards that support a plurality of probe needles must provide reliable electrical contact with the bonding pads of the DUT. The shank of the probe needle is typically 0.005 inches to 0.010 inches in diameter.

One test probe technique is known as the Cobra system, in which the upper ends of the probe needles are guided through a rigid layer of an insulating material. The upper ends of the individual probe needles are electrically connected to suitable conductors of an interface assembly that is connected to an electrical test system. Each of the needles is curved and the 25 lower ends pass through a corresponding clearance hole in a lower rigid layer or template of insulating material. The bottom ends of the needles contact the bonding pads on the wafer being tested. The length of the probe needles can result in undesirable levels of ground noise and power supply noise to the DUT. Additionally, the epoxy or plastic rigid layers have large coefficients of thermal 30 expansion and cause errors in the positioning of the needle probes.

Another draw-back of current test probe technology is that it can often not accommodate fine pitches. For example, wafer probes typically require a target contact area of about 70 micrometers by 70 micrometers. Flip-chip architecture has terminals on the order of 10 micrometers by 10 micrometers, and hence, can not effectively be tested using wafer probe technology. Consequently, integrated circuits in flip-chip architectures can generally be tested only after packaging is completed. The inability to wafer probe integrated circuits used in flip-chip architecture results in production time delays, poor yields and a resultant higher cost.

Many of the problems encountered in testing electrical devices also occur in connecting integrated circuit devices to larger circuit assemblies, such as printed circuit boards or multi-chip modules. The current trend in connector design for those connectors utilized in the computer field is to provide both high density and high reliability connectors between various circuit devices. High reliability for such connections is essential due to potential system failure caused by misconnection of devices. Further, to assure effective repair, upgrade, testing and/or replacement of various components, such as connectors, cards, chips, boards, and modules, it is highly desirable that such connections be separable and reconnectable in the final product.

Pin-type connectors soldered into plated through holes or vias are among the most commonly used in the industry today. Pins on the connector body are inserted through plated holes or vias on a printed circuit board and soldered in place using conventional means. Another connector or a packaged semiconductor device is then inserted and retained by the connector body by mechanical interference or friction. The tin lead alloy solder and associated chemicals used throughout the process of soldering these connectors to the printed circuit board have come under increased scrutiny due to their environmental impact. Additionally, the plastic housings of these connectors undergo a significant amount of thermal activity during the soldering process, which stresses the component and threatens reliability.

The soldered contacts on the connector body are typically the means of supporting the device being interfaced by the connector and are subject to fatigue, stress deformation, solder bridging, and co-planarity errors, potentially causing premature failure or loss of continuity. In particular, as the 5 mating connector or semiconductor device is inserted and removed from the present connector, the elastic limit on the contacts soldered to the circuit board may be exceeded causing a loss of continuity. These connectors are typically not reliable for more than a few insertions and removals of devices. These devices also have a relatively long electrical length that can degrade system 10 performance, especially for high frequency or low power components. The pitch or separation between adjacent device leads that can be produced using these connectors is also limited due to the risk of shorting.

Another electrical interconnection method is known as wire bonding, which involves the mechanical or thermal compression of a soft metal 15 wire, such as gold, from one circuit to another. Such bonding, however, does not lend itself readily to high-density connections because of possible wire breakage and accompanying mechanical difficulties in wire handling.

An alternate electrical interconnection technique involves placement of solder balls or the like between respective circuit elements. The 20 solder is reflowed to form the electrical interconnection. While this technique has proven successful in providing high-density interconnections for various structures, this technique does not facilitate separation and subsequent reconnection of the circuit members.

An elastomer having a plurality of conductive paths has also been 25 used as an interconnection device. The conductive elements embedded in the elastomeric sheet provide an electrical connection between two opposing terminals brought into contact with the elastomeric sheet. The elastomeric material must be compressed to achieve and maintain an electrical connection, requiring a relatively high force per contact to achieve adequate electrical 30 connection, exacerbating non-planarity between mating surfaces. Location of

the conductive elements is generally not controllable. Elastomeric connectors may also exhibit a relatively high electrical resistance through the interconnection between the associated circuit elements. The interconnection with the circuit elements can be sensitive to dust, debris, oxidation, temperature fluctuations, vibration, and other environmental elements that may adversely affect the connection.

5 The problems associated with connector design are multiplied when multiple integrated circuit devices are packaged together in functional groups. The traditional way is to solder the components to a printed circuit board, flex circuit, or ceramic substrate in either a bare die silicon integrated circuit form or packaged form. 10 Multi-chip modules, ball grids, array packaging, and chip scale packaging have evolved to allow multiple integrated circuit devices to be interconnected in a group.

15 One of the major issues regarding these technologies is the difficulty in soldering the components, while ensuring that reject conditions do not exist. Many of these devices rely on balls of solder attached to the underside of the integrated circuit device which is then reflowed to connect with surface mount pads of the printed circuit board, flex circuit, or ceramic substrate. In some circumstances, these joints are generally not very reliable or easy to inspect for defects. The process to remove and repair a damaged or defective device is costly and many times results in unusable electronic components and damage to other components in the functional group.

20 Multi-chip modules have had slow acceptance in the industry due to the lack of large scale known good die for integrated circuits that have been tested and burned-in at the silicon level. These dies are then mounted to a substrate which interconnect several components. As the number of devices increases, the probability of failure increases dramatically. With the chance of one device failing in some way and effective means of repairing or replacing currently unavailable, yield rates have 25 been low and the manufacturing costs high.

U.S. Patent No. 5,252,916 (Swart) discloses a fluid-activated fixture for printed circuit boards. An electrically conductive barrel 22 (also referred to as an eyelet) is press fitted into each bore 20. Separate test probes 24 are movably mounted

in each of the barrels 22. A flex circuit 30 is laminated to a bottom surface of the upper probe plate 16. Each barrel 22 has an outer flange that pierces a circuit trace and seats the flange to the circuit trace to form an electrical connection. The test probes 24 are movable axially in their respective barrels freely and under gravity. The test probes 5 slide on the inside of the barrels 22 for making sliding electrical contact. The barrels 22 press fit into the support plate 16 make electrical contact with the flexible circuit 30. The first ends of the test probes 24 are supported by a flexible elastomeric diaphragm 42.

U.S. Patent No. 4,118,090 (Del Mei) discloses a plurality of movable 10 electrically conductive contacts 10 slidably located in cylindrical apertures 14 in a locating element 16. The contacts 10 are each attached to an electrically insulating elastomeric element 18 which has been bonded to the contacts by molding the element 18 about the contacts 10. A retaining member 20 is provided on the opposite side of the elastomeric element 18 to the locating element and traps the elastomeric element 15 between itself and the locating element.

WO 98/13695 discloses a connector apparatus in which an anisotropic compliant conductive interposer 214 electrically couples contact elements 208 to contact pads 322 on an interface board 320. Stop rings 312 retain the contact elements 208 in the guide plate 108. The anisotropic interposer 214 is comprised of an 20 elastomeric sheet 350 with a plurality of conductors 352. The interposer 214 serves as a pass-through for electrical signals between the contact elements 208 and the interface board 320.

U.S. Patent No. 5,723,347 (Hirano et al.) discloses a probe structure with 25 a plurality of conductive contacts formed on a film stretched across a plurality of cavities in a substrate. The cavities and the conductive contacts are aligned to one another and both match the positions of selected I/O pads on the device to be probed.

U.S. Patent No. 5,412,329 (Iino et al.) discloses a probe card having a supporting plate, a flexible printed circuit base including a flexible film base material supported by the supporting plate, circuits printed on the film base material being

connected electrically to a tester, contactors connected electrically to the printed circuits and adapted to be brought into contact with the pads in equally corresponding relation, and a cushioning medium designed so as to back up a section in which the contactors are mounted. When the contactors are brought into contact with the pads, 5 individually, the cushioning medium undergoes an elastic deformation, so that the contact between the contactors and the pads is improved.

EP 0 310 302 discloses a test socket for testing chips and chips on tape wherein the test socket is formed on a heat resistant dielectric film having contact pads and connector pads joined by metallic circuit traces and which film is wrapped on a 10 compliant pad. The connector end of the tape is joined to a circuit board by a conductive tape and maintained in contact by the compliant pad. A frame registers the chip with the contact area of the tape.

Brief Summary of the Invention

The present invention is directed to a method and apparatus for achieving a very fine pitch interconnect between a flexible circuit member and another circuit member with extremely co-planar electrical contacts that have a large range of compliance. The second circuit member can be a printed circuit board, another flexible circuit, a bare-die device, an integrated circuit device, an organic or inorganic substrate, a rigid circuit and virtually any other type of electrical component.

10           The present invention is also directed to an electrical interconnect assembly comprising a flexible circuit member electrically coupled to an electrical connector in accordance with the present invention. The present electrical interconnect assembly can be used as a die-level test probe, a wafer probe, a printed circuit probe, a connector for a packaged or unpackaged circuit 15          device, a conventional connector, a semiconductor socket, and the like.

10           The present method includes preparing a plurality of through holes extending between a first surface and a second surface of a housing. Each of the through holes defines a central axis. A plurality of elongated electrical contacts are positioned in at least some of the through holes and oriented along 20          the central axis. The electrical contacts have first ends that extend beyond the first surface. The electrical contacts are retained in the through holes by a variety of techniques. The first ends of the electrical contacts are electrically coupled to contact pads or terminals on a flexible circuit so that the second ends of the electrical contacts extend beyond the second surface. The second ends of 25          the electrical contacts are then free to electrically couple with a second circuit member. A resilient member controls movement of the electrical contacts along their respective central axes within the housing.

10           The step of retaining the electrical contacts in the through holes can be achieved by interposing a compliant encapsulating material between a 30          portion of the through holes and a portion of the electrical contacts, surrounding

a portion of the electrical contacts with an encapsulating material along one of the surfaces of the housing, bonding the first end of the electrical contacts to the terminals on the flexible circuit, and/or positioning a compliant material along a surface of the flexible circuit opposite the terminals. A back-up member may 5 optionally be positioned behind the compliant material. In one embodiment, the compliant encapsulant elastically bonds the electrical contacts to the housing.

In one embodiment, the step of positioning the plurality of electrical contacts includes applying a solder mask material or comparable dissolvable/removable material along the first surface. The solder mask 10 material and a portion of the electrical contacts extending above the first surface are planarized. When the solder mask is removed, the electrical contacts have precisely formed end surfaces that extends above the first surface of the housing. The resilient member can optionally be applied to the electrical contacts either before application of the solder mask or after removal of the 15 solder mask.

The ends of the electrical contacts can be modified by a variety of techniques, such as etching, grinding, abrasion, ablation or the like. The ends of the electrical contacts can also be modified to have a shape that facilitates engagement with various structures on the flexible circuit member or 20 the second circuit member. The second ends of the electrical contacts can be configured to engage with another flexible circuit, a ribbon connector, a cable, a printed circuit board, a bare die device, a ball grid array, a land grid array, a plastic leaded chip carrier, a pin grid array, a small outline integrated circuit, a dual in-line package, a quad flat package, a flip chip, a leadless chip carrier, and 25 a chip scale package.

The first ends of the electrical contacts are electrically coupled to the flexible circuit bonding pads using a variety of techniques, such as a compressive force, solder, wedge bonding, conductive adhesives, solder paste, ultrasonic bonding, wire bonding, or a combination thereof. In one

embodiment, the flexible circuit is bonded to the first surface of the housing with an adhesive.

The electrical connector in accordance with the present invention includes a housing with a plurality of through holes extending between a first surface and a second surface. A plurality of elongated electrical contacts are positioned in the through holes and oriented along the central axis. The first ends of the electrical contacts are electrically coupled to the terminals on the flexible circuit. The second ends extend beyond the second surface of the housing to couple electrically with the second circuit member. A resilient member controls movement of the electrical contacts along their respective central axes. The resilient member can be an encapsulating material interposed between a portion of the through hole and a portion of the electrical contacts, an encapsulating material surrounding a portion of the electrical contacts along one of the surfaces of the housing, the flexible circuit bonded to the contacts, a singulated terminal on the flexible circuit, and/or a compliant material positioned along a surface of the flexible circuit opposite the terminals.

The electrical contacts can be a multi-layered construction or a homogenous material. The electrical contacts may have a cross-sectional shape of circular, oval, polygonal, or rectangular. The electrical contacts can have a pitch of less than about 0.4 millimeters and preferably a pitch of less than about 0.2 millimeters.

The present invention is also directed to an electrical interconnect assembly comprising a flexible circuit bonded to the first ends of the electrical contacts in the housing. A resilient member controls movement of the electrical contacts along their respective axes. The second ends of the electrical contacts are free to engage with a variety of second circuit members, or to operate as test probes for testing various electrical components.

Brief Description of the Drawings

Figure 1 is a side sectional view of an electrical interconnect in accordance with the present invention.

Figure 1A is a side sectional view of an alternate electrical 5 interconnect in accordance with the present invention.

Figure 1B is a side sectional view of another alternate electrical interconnect in accordance with the present invention.

Figure 2 is a side sectional view of a method of modifying the electrical interconnect of Figure 1.

10 Figure 3 is a side sectional view of a method of modifying the electrical interconnect of Figure 2.

Figure 4 is a side sectional view of an electrical contact modified in accordance with the method of the present invention.

15 Figure 5 is a side sectional view of an electrical contact modified in accordance with an alternate method of the present invention.

Figure 6 is a side sectional view of an electrical contact bonded to a flexible circuit in accordance with the present invention.

20 Figure 7 is a side sectional view of an alternate method of bonding the flexible circuit to the electrical contact in accordance with the present invention.

Figure 8 is a side sectional view of an alternate method of bonding the flexible circuit to the electrical contact in accordance with the present invention.

25 Figure 9 is a side sectional view of an electrical interconnect bonded to a flexible circuit in accordance with the present invention.

Figure 9A is a side sectional view of an alternate electrical interconnect bonded to a flexible circuit in accordance with the present invention.

30 Figure 10 is a perspective view of an flexible circuit member in accordance with the present invention.

Figure 11 is a side sectional view of a singulated flexible circuit in accordance with the present invention.

Figure 11A is a non-singulated flexible circuit in accordance with the present invention.

5           Figure 12 is side sectional view of an alternate electrical interconnect bonded to a flexible circuit member in accordance with the present invention.

Figure 13 is a side sectional view of a flexible circuit bonded to an electrical interconnect in accordance with the present invention.

10          Figure 14 is a side sectional view of the electrical interconnect of Figure 13 in an engaged state.

Figure 15 is a side sectional view of an alternate electrical interconnect bonded to a singulated flexible circuit in accordance with the present invention.

15          Figure 15A is side sectional view of an alternate electrical interconnect in which the flexible circuit and encapsulating material are singulated in accordance with the present invention.

Figure 16 is a side sectional view of an electrical interconnect assembly in accordance with the present invention engaged with a second circuit member.

20          Figure 17 is a side sectional schematic illustration of an electrical interconnect assembly in which both surfaces of the flex circuit member are used for forming electrical connections.

Figure 18 is a side sectional view of two electrical interconnects in accordance with the present invention in a stacked configuration.

25          Figure 19 is a replaceable chip module coupled to a flexible circuit member using the controlled compliance interconnect of the present invention.

Figure 20 is a pair of replaceable chip modules in a stacked configuration coupled by a flexible circuit member using the controlled compliance interconnect of the present invention.

5 Figure 21 is a side sectional view of an electrical interconnect bonded to a two-sided flexible circuit in accordance with the present invention.

Figure 22 is a side sectional view of an electrical interconnect assembly in accordance with the present invention.

Figure 23 is a perspective view of an electrical interconnect coupled to a display in accordance with the present invention.

10 Figure 24 is a schematic illustration of an electrical interconnect used as a test probe in accordance with the present invention.

Figure 25 is a perspective view of electrical interconnect used as a test probe for wafer level devices in accordance with the present invention.

15 Figure 26 is a side sectional view of a two-sided electrical interconnect in accordance with the present invention.

Figure 27A is a side sectional view of an electrical interconnect assembly in a disengaged configuration in accordance with the present invention.

20 Figure 27B is a side sectional view of the electrical interconnect assembly of Figure 27A in an engaged configuration in accordance with the present invention.

Figure 28A is a side sectional view of an alternate electrical interconnect assembly in a disengaged configuration in accordance with the present invention.

25 Figure 28B is a side sectional view of the electrical interconnect assembly of Figure 28A in an engaged configuration in accordance with the present invention.

Detailed Description of the Invention

Figure 1 is a side sectional view illustrating a step in the method of making an electrical interconnect 30 in accordance with the present invention. Housing 32 has a plurality of through holes 34 that extend from a first surface 36 to a second surface 38. Each of the holes 34 defines a central axis 40. Housing or interposer 32 may be constructed from a dielectric material, such as plastic, ceramic, metal with a non-conductive coating. The holes can be formed by a variety of techniques, such as molding, laser drilling, or mechanical drilling. The holes 34 can be arranged in a variety of configuration, including one or two-dimensional arrays. The housing 32 may optionally include a tooling hole 42 to facilitate handling and alignment with other components.

A plurality of rigid or semi-rigid electrical contacts 44 are positioned in some or all of the holes 34. The electrical contacts 44 may be positioned in the holes 34 by a variety of techniques, such as manual assembly, vibratory assembly, or robotic assembly. In the illustrated embodiment, the electrical contacts 44 are maintained in their desired location by a height fixture 46. Upper ends 62 of the electrical contacts 44 may exhibit height differences based upon the manufacturing tolerances and constancy of the manufacturing process.

The electrical contacts may be a variety of materials, such as wire, rod, formed strips, or turned or machined members. The electrical contacts can have a cross-sectional shape that is circular, oval, polygonal, or the like. The electrical contacts can be made from a variety of materials, such as gold, copper, copper alloy, palladium, or nickel. The electrical contacts 44 are typically cut or formed into a general length, which reduces cost and handling difficulties. The electrical contacts are modified during subsequent processing steps to achieve the necessary precision, such as planarity and tip shape. In order to achieve a fine pitch without shorting, the electrical contact must typically be straight to within about 0.25 millimeters and be rigid or semi-rigid

in construction. The electrical contacts 44, however, may have a different cross section at various locations along their entire length (see Figure 1A).

In the embodiment illustrated in Figure 1, a compliant encapsulating material 50 is applied to the first surface 36. The compliant encapsulating material 50 surrounds the electrical contacts 44 and bonds to the first surface 36. In the illustrated embodiment, the compliant encapsulating material penetrates at least part way into the holes 34. In an alternate embodiment, the encapsulating material 50 remains generally on the surface 36. The compliant encapsulating material 50 permits the electrical contacts 44 to move elastically along the central axis 40, while retaining them in the housing 32. Suitable compliant encapsulating materials include Sylgard® available from Dow Corning Silicone of Midland, Michigan, and MasterSyl 713, available from Master Bond Silicone of Hackensack, New Jersey.

Figure 2 illustrates another step in the method of forming the electrical interconnect 30 in accordance with the present invention. The first surface 36 and/or the second surface 38 are flooded with one or more retention materials 60 that will assist in the further processing steps. The retention material 60 can be a compliant encapsulant or a material that cures solid, such as a solder mask. Once the retention material 60 has cured, the electrical contacts 44 are rigidly held to the housing 32 so that the fixture 46 can be removed. The material retention 60 can optionally be applied to the second surface 38. In an alternate embodiment, the compliant encapsulating material 50 is omitted and the retention material 60 is applied directly to the first surface 36.

Figure 3 is a side sectional view showing a subsequent step in the processing of the electrical interconnect 30 in accordance with the present invention. The retention material 60 retains the electrical contacts 44 in the housing 32 so that ends 62, 64 can be processed without flexural displacement or damage. The assembly is subjected to a precision grinding operation, which results in very flat ends 62, 64 on the electrical contacts 44, typically within

about 0.0005 inches. The grinding operation can be performed on both sides at the same time using a lapping or double grinding process. In an alternate embodiment, only one surface 36, 38 of the electrical interconnect 30 is subject to the planarization operation. The retention material 60 is then dissolved from 5 the electrical interconnect 30 to expose the first and second ends 62, 64, of the electrical contacts 44 (see Figure 9). In an alternate embodiment, the first and/or second ends 62, 64 of the electrical contacts are subject to further processing prior to removal of the material 60.

Figure 1A illustrates an alternate embodiment method of making 10 an electrical interconnect 30' in accordance with the present invention. Upper ends 62' of the electrical contacts 44' have a cross sectional portion 61' that is larger than the cross sectional area of the holes 34' that engages with the first surface 36'. Consequently, the electrical contacts 44' are always oriented in the same direction in the housing 32', even when positioned using automated 15 processes such as vibratory assembly. The cross sectional portion 61' also makes the fixture 46 of Figure 1 unnecessary. The electrical interconnect 30' may subsequently processed as discussed herein, such as application of a compliant encapsulating material 50'. Alternatively, the upper ends 62' can be deformed during a subsequent processing step.

Figure 1B illustrates another alternate embodiment method of 20 making an electrical interconnect 30" in accordance with the present invention. In the illustrated embodiment the electrical contacts 44" are generally of the same length. Fixture 46" has support surfaces at various levels relative to second surface 38" of housing 32". Consequently, the electrical contacts 44" 25 are maintained in the holes 34" in a step configuration. The electrical interconnect 30" may be subsequently processed as discussed herein, such as application of a compliant encapsulating material 50". In one embodiment, a retention material 60 (see Figure 2) is applied to the first surface 36". The ends 62" of the electrical contacts 44" are planarized, such as is illustrated in Figure

3. The ends 64" extending beyond the surface 38", however, are not planarized and retain the step configuration.

Depending on the material of the electrical contacts 44 and the desired function, the planar ends 62, 64 may exhibit different properties. If the 5 electrical contacts are made of a copper base metal or alloy and plated with a barrier layer and a gold layer, the grinding process will remove the nickel and gold from the tips, exposing base metal that will oxidize. If the electrical contact 44 is a material such as gold or palladium, corrosion is minimized. The ends 62, 64 can be tailored for specific applications, such that the first end 62 10 may have a different structure or shape than the second end 64.

Depending on the type of terminal the electrical contact 44 is intended to interface with, it may be desirable to abrasively process the tips such that the ends 62, 64 are still essentially planar but have a surface which is more irregular than that left by the grinding process. This abrasive processing 15 can also be of a cleaning nature to remove any oxides formed between process steps. Figure 4 illustrates one embodiment of an ends 62, 64 of an electrical contact 44 that has been subject to an abrasive blast operation to provide a correspondingly rough surface.

Figure 5 illustrates an alternate ends 62, 64 of an electrical 20 contact 44 that has been subject to an etching process. In the illustrated embodiment, the electrical contact 44 is constructed from a copper alloy core 70, an intermediate nickel layer 72 and an outer gold layer 74. When subjected to an etching solution, only the copper alloy 70 is removed. In the illustrated embodiment, the ends 62, 64 has a generally concave tip shape, where the outer 25 walls 72, 74 extend beyond the post-processed base metal 70. The ends 62, 64 can then be processed to deposit another barrier to prevent contamination by oxides, such as a gold layer (see Figure 6). In some instances, it may be acceptable to leave the base metal 70 untreated.

The generally concave shape of the ends 62, 64 can provide 30 several desired functional properties, such as contacting a solder, gold, or other

deposits in a generally mating fashion, without excessively deforming the deposits. Additionally, the protruding outer wall 72, 74 provides a slight wiping action during mating with the corresponding component. The outer walls 72, 74 form a tubular structure that increases the pressure per unit area  
5 when compressively engaged with a mating electrical circuit member. Finally, the concave shape of the ends 62, 64 provides a reservoir for contamination on the terminal of the mating circuit member, while the relatively hard outer layer 72, 74 minimize deformation of the tip 62, 64. The etching process may be performed either before or after removal of the material 60.

10 Figure 6 is a side sectional view of a flexible circuit member 80 being bonded to a electrical contact 82 in accordance with the present invention. The electrical contact 82 includes a barrier layer 84 along the ends 62, 64. In the illustrated embodiment, the terminals 86 on the flexible circuit member 80 include a ball structure 88 having a shape corresponding to the ends 62, 64 of  
15 the electrical contact 82. The ball structure 88 can be constructed from gold, solder, or a conductive adhesive. The ball structure 88 is aligned to each corresponding electrical contact ends 62, 64 and ultrasonically bonded. Alternatively, the ball structure 88 can be a solder ball or deposit, which can then be reflowed to attach each electrical contact member 82. Several iso-tropic  
20 and anisotropic conductive adhesives are available to achieve similar results. In another embodiment, the ball structure 88 can be electrically coupled to the ends 62, 64 by a compressive force.

Figure 7 is a side sectional view of an alternate electrical contact 90 in accordance with the present invention. A barrier layer 92, such as gold, is  
25 deposited on the generally planar ends 62, 64 of the electrical contact 90. The ball structure 88 of the flexible circuit member 80 is then bonded to the barrier layer 92. Figure 8 is a side sectional view of a high density, flexible circuit member 100 being bonded to the electrical contact 90 using a wire bonding technique.

Figure 9 is a side sectional view of an electrical interconnect 110 electrically coupled to bonding pads 113 on a flexible circuit member 112 in accordance with the present invention. In the illustrated embodiment, the resilient encapsulating material 114 retains the electrical contacts 116 within the 5 housing 118, but permits movement along the central axes. The first ends 120 of the electrical contacts 116 may be electrically coupled with the flexible circuit 112 using a variety of techniques discussed herein, such as applying a compressive force, solder, wedge bonding, conductive adhesives, ultrasonic bonding and wire bonding. The second ends 122 of the electrical contacts 116 10 extend beyond the second surface 124 of the housing 118 to couple electrically with a second circuit member (see Figure 16).

Figure 9A illustrates an alternate embodiment of an electrical interconnect 110' electrically coupled a flexible circuit member 112' in accordance with the present invention. The flexible circuit member 112' has a 15 series of pass through openings. The flexible circuit member 112' is aligned to the electrical contacts 116' such that the pass though openings are located directly on each electrical contact end 120' in the array. A gold ball bonder can then be used to bond the flexible circuit member 112' to the ends 120' of the electrical contacts 116', where the gold balls 115' extend to an exposed 20 conductive layer in the flexible circuit member 112'.

Once the flexible circuit member 112 is attached, several options can be employed to increase the function of the electrical interconnect 110. These features, discussed in detail below, provide a relatively large range of compliance of the electrical contacts 116, complimented by the extreme co- 25 planarity of the electrical contact ends 122. The nature of the flexible circuit 112 allows fine pitch interconnect and signal escape routing, but also inherently provides a mechanism for compliance. One option is to allow the flexing nature of the flexible circuit member 112 to provide compliance as the lower ends 122 are compressed. The semi-rigid or rigid nature of the electrical 30 contacts 116 will transmit the incident force to the flexible circuit member 112

and cause flexure at the area around the bond sites 113. The flexible circuit member 112 can be left separate from the housing 118 to allow a free range of movement or the flexible circuit 112 can be selectively bonded to the housing 118 to restrict movement if desired.

5                  Figure 10 is a perspective view of a flexible circuit member 140 in accordance with the present invention. The flexible circuit member 140 includes a series of electrical traces 142 deposited on a polymeric sheet 144 and terminating at a plurality of terminals or terminals 146. As used herein terminal refers to an electrical contact location or contact pad. In the illustrated 10 embodiment, the terminals 146 include a singulation 148. Singulation refers to a partial separation of the terminal from the sheet that does not disrupt the electrical integrity of the conductive trace. The partial separation can be a perforation in the polymeric sheet 144. Alternatively, singulation may include a thinning or point of weakness of the sheet material along the edge of, or directly 15 behind, the terminal. In the illustrated embodiment, singulating the flexible circuit member 140 near or around the terminals 146 releases or separates the terminal from the sheeting 144, while maintaining the interconnecting circuit traces 142. The singulations can be formed at the time of manufacture or the sheeting 144 can be subsequently patterned by stamping, cutting or a variety of 20 other techniques. In one embodiment, a laser system, such as Excimer, CO<sub>2</sub>, or YAG, creates the singulation 148. This structure is advantageous in several ways, where the force of movement is greatly reduced since the flexible circuit member 140 is no longer a continuous membrane, but a series of flaps or bond sites with a living hinge and bonded contact.

25                  In the illustrated embodiment, the singulation 148 is a slit surrounding a portion of the terminal 146. The slit may be located adjacent to the perimeter of the terminal 146 or offset therefrom. The singulation 148 may be formed to serve as the resilient member for controlling movement of the electrical contacts along their respective central axes. The singulated terminal 30 146 can be left free from the housing or it can be selectively bonded such that

the hinged portion is allowed to move freely within a given range. The singulated flexible circuit member 140 can also be encapsulated or mated with a compliant sheet to control the amount of force, the range of motion, or assist with creating a more evenly distributed force vs. deflection profile across the array (see Figure 11).

Figure 11 is a side sectional view of an electrical contact 150 electrically coupled to a flexible circuit member 152. The terminal 154 of the flexible circuit member 152 has been singulated at a location 156. A compliant encapsulating material 158 has been deposited on the surface of the flexible circuit member 152 opposite the electrical contact 150. Alternatively, the flexible circuit member 152 can be mated with a compliant sheet of material to provide controlled force and compliance. The additional layer of compliant encapsulant or sheeting can also be precision ground to provide uniform thickness and compliance across the array. In the illustrated embodiment, movement of the electrical contact 150 along the central axis 162 is controlled by the compliant encapsulant 166 deposited around the electrical contact 150, the resiliency of the flexible circuit member 152, and the resiliency of the compliant encapsulant 158. These components are engineered to provide a desired level of compliance to the electrical contact 150 within the housing 166.

In the illustrated embodiment, a portion of the compliant encapsulating material 160 has seeped through the singulation 156. The liquid nature of the uncured encapsulant can be taken advantage of by applying or injecting it into the singulation gap 157 under a slight vacuum condition in the region 159 between the flexible circuit member 152 and the encapsulant 166. The material 158 is drawn into the singulation gap 157. The encapsulated gap 157 supports and controls the motion of the terminal 154. This control can minimize the flexural stress and fatigue of the singulated terminal 154, increasing mechanical performance and life. In an alternate embodiment, the compliant sheet or encapsulant 158 can be applied prior to singulation of the flexible circuit member 152, such that the living hinge mechanism is a laminate

or composite of the compliant encapsulant 158 and the flexible circuit member 152.

Figure 11A is a side sectional view of an electrical contact 150A electrically coupled to a flexible circuit member 152A, without singulation of 5 the terminals 154A. A vacuum is applied in the region 159A between the flexible circuit member 152A and the encapsulant 166A prior to applying the compliant encapsulating material 168A. The vacuum draws the flexible circuit member 152A down at the bond sites 154A and forms a dimple 155A over the first end 157A of the electrical contact 150A. Application of the compliant 10 encapsulant 168A fills the dimples 155A, and when the vacuum is removed, the flexible circuit member 152A will have a different shape and a preload caused by the material 168A in the dimple 155A biasing the electrical contact 150A downward. A layer of compliant material 158A may optionally be applied to the outer surface of the flexible circuit member 152A.

15 Figure 12 is a side sectional view of an alternate electrical interconnect 170 in accordance with the present invention. The electrical contacts 172 have been prepared using the techniques discussed above, but no compliant encapsulating material was applied. Height fixture 174 retains the electrical contacts 172 at the desired position within the housing 176. A 20 flexible circuit member 178 is bonded to the first ends 180 of the electrical contacts 172, using any of the techniques discussed above. Once the electrical contacts 172 are bonded to the flexible circuit member 178, the fixture 174 can be removed. The electrical contacts 172 are then suspended within the housing 176 by the flexible circuit member 178. Compliance is provided by the 25 resiliency of the flexible circuit member 178. In one embodiment, the flexible circuit member is bonded to the housing 176. Other compliant members may optionally be added to the electrical interconnect 170.

30 Figure 13 is a side sectional view showing one embodiment of an electrical interconnect 190 in an disengaged configuration. The flexible circuit member 192 is bonded to the electrical contact 194 as discussed herein. No

encapsulating material is provided between the electrical contact 194 and housing 196. The electrical contact is suspended in the housing 196 by the flexible circuit member 192. The flexible circuit member 192 is optionally bonded to housing 196 with an adhesive layer 202. The flexible circuit member 5 192 is optionally singulated at the location 198 to provide a flexure point 200.

Figure 14 is a side sectional view of the electrical interconnect 190 of Figure 13 in an engaged configuration. The electrical contact 194 has been displaced in the direction 204, causing the flexible circuit member 192 to flex at the flexure point 200. In the embodiment illustrated in Figures 13 and 10 14, the sole resilient member is the flexible circuit 192. In alternate embodiments, a compliant encapsulating material may be positioned along the rear surface 206 of the flexible circuit member 192 (see Figures 11A, 11B and 15).

Figure 15 is a side sectional view of an electrical interconnect 15 210 in which the resiliency of a singulated, flexible circuit member 192 is supplemented by a compliant encapsulating material 212 positioned along the rear surface 214 of the flexible circuit 192 and a compliant encapsulating material 222 deposited between the flexible circuit 192 and the housing 196. The compliant encapsulating material 212 may be deposited as a liquid or 20 positioned in sheet form, as discussed above. An adhesive layer 216 may optionally be provided for retaining the flexible circuit member 192 to the housing 196.

Figure 15A is a side sectional view of an electrical interconnect 210A in which both the flexible circuit member 192A and the compliant 25 encapsulating material 212A are singulated at a location 218A. The compliant encapsulating material 212A may be deposited in liquid form or positioned as a sheet form, as discussed above. An adhesive layer 216A may optionally be provided for retaining the flexible circuit member 192A to the housing 196A. The flexible circuit member 192A may be singulated prior to application of the 30 encapsulating material 212A, or simultaneously therewith. A back-up member

220A may optionally be located behind the compliant material 192A to provide additional support. The back-up member 220A may be part of a larger assembly using the present electrical interconnect 210A.

Figure 16 is a side sectional view of an electrical interconnect assembly 230 in accordance with the present invention. First ends 232 of the electrical contacts 234 are electrically coupled to a flexible circuit 236, using any of the techniques described herein. A compliant encapsulant or sheet material 238 is deposited on the rear surface of the flexible circuit 236. The second ends 240 of the electrical contacts 234 extend beyond the second surface 242 of the housing 244 to couple electrically with terminals 246 on a second circuit member 248. The terminals 246 may be a variety of structures such as, for example, a ball grid array, a land grid array, a pin grid array, contact points on a bare die device, etc. Similarly, the second ends 240 of the electrical contacts 234 can be a variety of shapes as discussed herein. The second circuit member 248 can be a printed circuit board, another flexible circuit, a ribbon cable, a bare die device, an integrated circuit device, organic or inorganic substrates, a rigid circuit or a variety of other electrical components.

In the illustrated embodiment, the electrical interconnect assembly 230 is releasably coupled to the second circuit member 248 by a compressive force 249. The compliance of the flexible circuit member 236, compliant material 238 and encapsulating material between the electrical contacts 234 and the housing 244, if any, provides the electrical contacts 234 with a large range of compliance along the central axes 247. Consequently, a stable electrical connection can be formed without permanently bonding the second ends 240 to the terminals 246. The electrical interconnect assembly 230 can serve as a die level test probe, a wafer probe, a printed circuit probe, or a variety of other test circuits. The various compliant members in the assembly 230 permit it to be oriented in any direction without interfering with its functionality.

The nature of the flexible circuit member 236 allows for a high density routing to external circuitry or electronics. The present electrical interconnection methodology can be extended to the distal end of the flexible circuit member 236 as well, to achieve a high performance connection where 5 previous methods relied on cabling, spring probes, or masses of bundled wires.

Figure 17 is a side sectional schematic illustration of an electrical interconnect assembly 280 in which both surfaces of the flex circuit member 282 can be used for forming electrical connections. The flex circuit member 282 is bonded to housing 284 by an adhesive 286. Singulation 288 is formed in 10 the flex circuit members 282 around trace 290. Electrical contact 292 is positioned to be compressively engaged with the trace 290 between circuit member 294 and controlled compliance layer 296 (see generally Figures 15A and 15). Solder balls 298 electrically coupled with one or more traces are located on the opposite side of the flex circuit member 282 for engagement with 15 circuit members or other electrical interconnect assemblies.

Figure 18 is a schematic illustration of two electrical interconnect assemblies 250, 252 arranged in a stacked configuration in accordance with the present invention. First ends 254 of the electrical contacts 256 are electrically coupled with a flexible circuit member 258. The flexible circuit member 258 is 20 folded around a compliant layer 260 so that first ends 262 of electrical contacts 264 in the electrical interconnect assembly 252 are also electrically coupled to the flexible circuit member 258. Second ends 266 of the electrical contacts 256 are electrically coupled with a second circuit member 268. Second ends 270 of the electrical contacts 264 are electrically coupled with circuit member 272. An 25 alignment member 274 is optional provided on the interconnect assembly 252 to position the circuit member 272 relative to the electrical contacts 264. The electrical interconnect assemblies 250, 252 of Figure 17 permit two circuit devices 268, 272 to be arranged in a stacked configuration.

Figure 19 illustrates a replaceable chip module 310 coupled to a 30 flexible circuit member 312 using the controlled compliance interconnect of the

present invention. Housing 314 has a plurality of device sites 316, 318 for receiving circuit members, such as an array of integrated circuit devices. The device sites 316, 318 are recesses that each contain an array of electrical contacts, such as discussed herein. The housing 314 is retained against the 5 flexible circuit member 312 using any of the methods discussed herein, such as mechanical fasteners, adhesives, secondary fixtures, etc. A controlled compliance layer 320 is optionally located behind the flexible circuit member 312. A stiffener 322 is optionally located behind the controlled compliance layer 320. The flexible circuit member 312 can be formed with or without 10 singulation. In the illustrated embodiment, the flexible circuit member has a series of terminals 326 for electrically coupling the replaceable chip module 310 with another circuit member. Alignment holes 324 are optionally provided on the housing 314 for receiving a cover (not shown) that retains circuit members in the device sites 316, 318 and provides a compressive force.

15                 The housing 314 allows for a great deal of configuration flexibility, such that it can be populated, upgraded, enhanced, or modified simply by removing, replacing, or adding individual circuit members or devices. The replaceable chip module 310 of Figure 19 is suited as a test fixture for evaluating circuit members. Conventional test or load boards used as 20 the interface for testing electrical devices can be greatly simplified or in some cases completely eliminated along with the supporting mechanical and electrical support or interface structure. The replaceable chip module technology disclosed in U.S. Patent Serial No. 08/955,563, entitled Replaceable Chip Module, is suitable for use in the present invention.

25                 Figure 20 is a side sectional schematic illustration of a pair of replaceable chip module 330, 332 using the controlled compliance interconnect of the present invention in a stacked configuration, coupled together by a flexible circuit member 334. The flexible circuit member 334 is folded around a compliant layer 336, such as is illustrated in Figure 18. The assembly 338 of 30 the folded flexible circuit member 334 and compliant layer 336 is retained in a

cavity 340 formed between the first replaceable chip module 330 and the second replaceable chip module 332. The various interfaces 341 between the flexible circuit member 334 and the electrical contacts 342, 344 of the respective replaceable chip modules 330, 332 can be formed using any of the 5 techniques disclosed herein. For example, the electrical contacts 342 are illustrated as coupling with a ball grid array on circuit member 346. Electrical contacts 344 can couple with another replaceable chip module, another flexible circuit members or various circuit members. An alignment structure 346 may optionally be located on the second replaceable chip module 332 for positioning 10 circuit members.

Figure 21 is a side sectional view of an electrical interconnect 400 in accordance with the present invention. Housing 402 includes an array of holes 404 each having a step 406. Electrical contacts 408 include a shoulder 410 adapted to engage with the step 406. Consequently, the electrical contacts 15 408 can move in the holes 404 along the central access 412 until the shoulders 410 engage with the steps 406. First ends 414 of the electrical contacts 408 extend above surface 416 of housing 402.

Second ends 418 of the electrical contacts 408 are electrically coupled to contact pads on flexible circuit member 420 using any of the 20 methods discussed herein. The flexible circuit member optional includes singulations 422 adjacent to one or more of the electrical contacts 408. A compliant material 424 is positioned on the opposite side of the flexible circuit member 420 behind the second ends 418 of each of the electrical contacts 408. The compliant material 424 biases the electrical contacts 408 in the direction 25 426.

The second surface 430 of the flexible circuit member 420 optionally includes a series of solder balls 432 electrically coupled to traces on the flexible circuit member 430. Solder paste 434 may optionally be applied to the solder balls 432.

Figure 22 illustrates an electrical interconnect assembly 440 utilizing the electrical interconnect 400 of Figure 21. The electrical interconnect 400 is located in an alignment device 442 positioned on a first circuit member 444. Flexible circuit member 420 (see Figure 21) extends 5 beyond the alignment device 442 to connect with another circuit member. The solder balls 432 (see Figure 21) electrically couple the flexible circuit member 420 with contact pads on the circuit member 444. In the illustrated embodiment, the circuit member 444 is a printed circuit board or adapter. The circuit member 444 will typically include an additional connector, such as an 10 edge card connector or the socket 7 compatible BGA adapter 446 illustrated in Figure 22.

A second circuit member 450 is compressively engaged with the electrical interconnect 400. Alignment device 442 ensures that the contact pads on the second circuit member 450 align with the electrical contacts 408 on the 15 electrical interconnect 400. Compliant material 424 biases the electrical contacts 408 into engagement with the contact pads on the second circuit member 450. In the illustrated embodiment, the second circuit member 450 is a land grid array (LGA) device. A heat sink 452 is optionally provided to retain the second circuit member 450 in compressive engagement with the electrical 20 interconnect 400.

Figure 23 illustrates an alternate electrical interconnect 460 in accordance with the present invention. Flexible circuit member 462 is electrically coupled to an array of pins (see generally Figure 21) retained in housing 464. The flexible circuit member 462 may optionally include an edge 25 card connector 466. The pins in the electrical interconnect 460 are compressively engaged with a land grid array device 468 on circuit member 470. In the illustrated embodiment, circuit member 470 is a display device. The embodiment illustrated in Figure 23 is particularly suited for use in lap top computers where the flexible circuit member 462 permits the display 470 to be 30 hinged to the chassis of the computer.

Figure 24 is a schematic illustration of an electrical interconnect 480 used as a probe module 482 in accordance with the present invention. Electrical contacts 484 are electrically coupled to flexible circuit 486. Compliant material 488 supported by back-up member 494 biases the electrical contacts 484 within the probe housing 490 towards a first circuit member 492. The first circuit member 492 can be a variety of electrical devices or a wafer containing a plurality of electrical devices (see Figure 25).

The flexible circuit 486 can extend to one or more circuit members. In the illustrated embodiment, the flexible circuit member 486 includes a first branch 496. The branch 496 includes a series of edge card pads (not shown) and a stiffening member 498 to form an edge card connector 500.

Second branch 502 extends to another electrical interconnect 504 that includes a compliant material 506, a backup member 508, and a series of electrical contacts 510 in a housing 512. The electrical interconnect 504 can be used to interface the probe module 482 to another circuit member 514, such as a printed circuit board.

The tester 516 illustrated in Figure 24 is completely modular. Any of the components can be easily replaced to facilitate testing of a wide variety of circuit members 492. For example, a different probe module 482 can be supplied so that the array of electrical contacts 482 correspond with the contact pads on the circuit member 492. Alternatively, the electrical interconnect 504 can be easily attached to a different circuit member 514 for performing different tests.

Figure 25 illustrates a system 520 for conducting full function testing at the wafer level. Electrical interconnect 522 includes a module holder 524 with a plurality of recesses 526. Each recess 526 is adapted to receive a probe module, such as illustrated in Figure 24. Each of the probe modules 528 includes a flexible circuit 530 that can be electrically coupled with one or more other circuit members for purposes of performing the testing.

Wafer 532 includes a plurality of electrical devices 534. The array of recesses on the module holder 524 correspond to the array of electrical devices 534 on the wafer 532. The electrical interconnect 522 is placed over the wafer 532 so that the electrical contacts (see Figure 24) of the probe modules 528 electrically couple with contact pads on the electrical devices 534. In one embodiment, the system 520 permits full speed testing of the electrical devices 534 at the wafer level.

Figure 26 is a schematic illustration of an alternate electrical interconnect 550 in accordance with the present invention. Flexible circuit member 552 electrically couples upper electrical contacts 554 and lower electrical contacts 556. Elastomer 558 is positioned to bias electrical contacts 554 upward in the direction 560. Upper housing 562 includes a recess 564 for receiving a variety of circuit members. Elastomer 566 biases lower electrical contacts 556 retained in the lower housing 568 in the direction 570 for coupling with another circuit member. In the embodiment illustrated in Figure 26, the upper housing 562 is a separate component from the lower housing 568.

Figure 27A is a schematic illustration of another electrical interconnect 580 in the disengaged configuration in accordance with the present invention. Substrate 582 supports a flexible circuit member 584 having a plurality of BGA contact pads 586. Electrical contacts 588 are electrically coupled to the opposite side of the flexible circuit member 584. Compliant member 590 is located behind each of the electrical contacts 588. Gaps 592 in the compliant member 590 permit solder balls 594 of a BGA device 596 to electrically couple with the BGA contact pads 586 on the flexible circuit member 584.

Figure 27B illustrates the electrical interconnect 580 of Figure 27A in the engaged configuration. The electrical interconnect 580 is compressed between the BGA device 596 and a second circuit member, such as a printed circuit board 598. The contact pads 600 on the printed circuit board 598 bias the electrical contacts 588 toward the BGA device 596. The compliant

material counteracts this bias on the electrical contacts 588. Singulations 602 in the flexible circuit member 584 facilitate movement of the electrical contacts 588 within the substrate 582. Solder balls 594 electrically couple with BGA contact pads 586 on the flexible circuit member 584.

5                  Figure 28A illustrates an electrical interconnect 620 substantially as shown in Figures 27A, except that the compliant material 622 includes a clearance opening or recess 624 immediately behind the electrical contact 626.

In the engaged configuration illustrated in Figure 27B, the  
electrical contacts 626 are biased toward the printed circuit board 628 only by  
10        the elastomeric properties of the flexible circuit member 628. In an alternate embodiment, the clearance opening 624 has a size that permits the electrical contact 626 to be supported substantially by the flexible circuit member 628 only for a portion of their travel. After an initial amount of travel by the electrical contact 626, the flexible circuit member 628 engages with the  
15        compliant material 622. Thereafter, further displacement of the electrical contact 626 is biased towards the printed circuit board 628 by a combination of the elastomeric properties of the flexible circuit member 628 and the compliant material 622.

20                  Patents and patent applications disclosed herein, including those cited in the background of the invention, are hereby incorporated by reference. Other embodiments of the invention are possible. It is to be understood that the above description is intended to be illustrative, and not restrictive. Many other embodiments will be apparent to those of skill in the art upon reviewing the  
25        above description. The scope of the invention should, therefore, be determined with reference to the appended claims, along with the full scope of equivalents to which such claims are entitled.

19 -07- 2001

## What Is Claimed Is:

1. An electrical connector for electrically interconnecting terminals on a flexible circuit member with terminals on a second circuit member, the electrical connector comprising:

5 a housing having a plurality of through holes extending between a first surface and a second surface, each of the through holes defining a central axis;

a plurality of elongated electrical contact members positioned in at least a portion of the through holes and oriented along the central axes, the electrical contact members having first ends extending above the first surface adapted to couple electrically with the terminals on the flexible circuit member, and second ends extending above the second surface to couple electrically with the second circuit member; and

10 15 a resilient member comprises a compliant encapsulating material interposed between a portion of the through holes and a portion of the electrical contact members to control movement of the electrical contact members along their respective central axes.

2. The electrical connector of claim 1 wherein first ends of the electrical contact members are attached to the terminals on the flexible circuit member.

20 3. The electrical connector of claim 1 wherein the flexible circuit member comprises singulated terminals.

4. The electrical connector of claim 1 wherein the resilient member further comprises a compliant material positioned along a surface of the flexible circuit member opposite the terminals of the flexible circuit member.

25 5. The electrical connector of claim 4 further including a back-up member supporting the compliant material.

6. The electrical connector of claim 1 wherein the second surface of the housing includes at least one device site corresponding to the second circuit member.

5

7. The electrical connector of claim 1 wherein the second ends of the electrical contact members have a shape that corresponds to a shape of the terminals on the second circuit member.

10

8. The electrical connector of claim 1 wherein the second ends of the electrical contact members are capable of engaging with a connector member selected from the group consisting of a flexible circuit, a ribbon connector, a cable, a printed circuit board, a ball grid array (BGA), a land grid array (LGA), a plastic leaded chip carrier (PLCC), a pin grid array (PGA), a small outline integrated circuit (SOIC), a dual in-line package (DIP), a quad flat package (QFP), a leadless chip carrier (LCC), a chip scale package (CSP), or packaged or unpackaged integrated circuits.

15

9. The electrical connector of claim 1 wherein the electrical contact members are one of a homogeneous material or a multi-layered construction.

20

10. The electrical connector of claim 1 wherein the electrical contact members have a cross-sectional shape selected from one of circular, oval, polygonal, and rectangular.

25

11. The electrical connector of claim 1 wherein a portion of the flexible circuit member is bonded to the first surface of the housing with an adhesive.

12. The electrical connector of claim 1 wherein the electrical contact members are electrically coupled to the flex circuit using one or more of a compressive

force, solder, a wedge bond, a conductive adhesive, an ultrasonic bond and a wire bond.

13. The electrical connector of claim 1 wherein the second ends of at least two of the electrical contact members extend beyond the second surface of the housing by a different amount.

14. The electrical connector of claim 1 wherein electrical contact members have a larger cross section proximate the first end than at the second end.

10 15. The electrical connector of claim 1 wherein the plurality of through holes are arranged in a two-dimensional array.

16. The electrical connector of claim 1 wherein the resilient member comprises a compliant encapsulating member elastically bonding the electrical contact members to the housing.

20 17. An electrical connector for electrically interconnecting terminals on a flexible circuit member with terminals on a second circuit member, the electrical connector comprising:

a housing having a plurality of through holes extending between a first surface and a second surface, each of the through holes defining a central axis;

25 a plurality of elongated electrical contact members positioned in at least some of the through holes and oriented along the central axes, the electrical contact members having first ends extending above the first surface that are attached to, and electrically coupled with, the terminals on the flexible circuit member, the flexible circuit member controlling movement of the electrical contact members along their respective central axes, and second ends extending above the second surface to couple electrically with the second circuit member.

18. The electrical connector of claim 17 wherein the flexible circuit member comprises singulated terminals.

5 19. The electrical connector of claim 17 comprising a compliant material positioned along a surface of the flexible circuit member opposite the terminals of the flexible circuit member.

10 20. The electrical connector of claim 17 comprising a compliant encapsulating member elastically bonding the electrical contact members to the housing.

21. The electrical connector of claim 17 wherein the second surface of the housing includes at least one device site.

15 22. The electrical connector of claim 17 wherein the second circuit member is one of a printed circuit board, a flexible circuit, a bare-die device, an integrated circuit device, an organic or inorganic substrate, a rigid circuit, or a wafer containing a plurality of integrated circuit devices.

20 23. The electrical connector of claim 17 wherein the second ends of the electrical contact members comprises one or more of die level test probes, wafer probes, and printed circuit board probes.

25 24. The electrical connector of claim 17 comprising a compliant encapsulating member elastically bonding the electrical contact members to the housing.

25. The electrical connector of claim 17 wherein a portion of the flexible circuit member is bonded to the first surface of the housing with an adhesive.

5 26. The electrical connector of claim 17 wherein the electrical contact members are electrically coupled to the flex circuit using one or more of compressive force, solder, a wedge bond, a conductive adhesive, an ultrasonic bond and a wire bond.

10 27. The electrical connector of claim 17 wherein the first end of at least one of the electrical contact members extends through the flexible circuit member.

15 28. The electrical connector of claim 17 wherein the flexible circuit member is folded over a resilient member to electrically couple two electrical interconnect assemblies in a stacked configuration.

20 29. The electrical connector of claim 17 wherein the flexible circuit member comprises electrical contact pads along a second surface thereof.

30. An electrical interconnect assembly using the electrical connector of claim 21 comprising:

a flexible circuit member having a plurality of terminals;

25 a first housing having a plurality of through holes extending between a first surface and a second surface, each of the through holes defining a central axis, a plurality of elongated electrical contact members positioned in at least some of the through holes and oriented along the central axes, the electrical contact members having first ends extending above the first surface that are attached to, and electrically coupled with, terminals on the flexible circuit member, the flexible circuit member controlling movement of the electrical contact members along their respective central

axes, and second ends extending above the second surface to couple electrically with the second circuit member;

5            a second housing having a plurality of through holes extending between a first surface and a second surface, each of the through holes defining a central axis, a plurality of elongated electrical contact members positioned in at least some of the through holes and oriented along the central axes, the electrical contact members having first ends extending above the first surface and electrically coupled to terminals on the flexible circuit member, and second ends extending above the second surface to couple electrically with the third circuit member, the first surface of the first housing being positioned opposite the first surface of the second housing; and

10            a resilient member controlling movement of the electrical contact members in the second housing along their respective central axes.

31.        A method of making an electrical interconnect comprising the  
15 steps of:

providing a housing with a plurality of through holes extending between a first surface and a second surface, each of the through holes defining a central axis;

positioning a plurality of elongated electrical contact members in at least some of the through holes oriented along the central axes, the electrical contact members having first ends extending above the first surface;

retaining the electrical contact members in the through holes; and

attaching and electrically coupling the first ends of the electrical contact members to the terminals on a flexible circuit member to control movement of the electrical contact members along their respective central axes and so that the second ends extending above the second surface.

25            32.        The method of claim 31 comprising the step of bonding the electrical contact members to the housing using a compliant material.

33. The method of claim 31 comprising the step of singulating one or more of the terminals on the flexible circuit member.

5 34. The method of claim 31 wherein the step of retaining the electrical contact members in the through holes comprises interposing a compliant encapsulating material between a portion of the through holes and a portion of the electrical contact members.

10 35. The method of claim 31 wherein the step of retaining the electrical contact members in the through holes comprises surrounding a portion of the electrical contact members with a compliant encapsulating material along the first surface of the housing.

15 36. The method of claim 31 wherein the step of retaining the electrical contact members in the through holes comprises positioning a compliant material along a surface of the flexible circuit member opposite the terminals.

37. The method of claim 31 comprising positioning a compliant material along a surface of the flexible circuit member opposite the terminals.

20 25 38. The method of claim 31 comprising the step of modifying the second ends of the electrical contact members to have a shape capable of engaging with a second circuit member selected from the group consisting of a flexible circuit, a ribbon connector, a cable, a printed circuit board, a ball grid array (BGA), a land grid array (LGA), a plastic lead chip carrier (PLCC), a pin grid array (PGA), a small outline integrated circuit (SOIC), a dual in-line package (DIP), a quad flat package (QFP), a leadless chip carrier (LCC), a chip scale package (CSP), packaged and unpackaged integrated circuits.

39. The method of claim 31 wherein the electrical contact members are electrically coupled to the flex circuit using one or more of compressive forces, solder, wedge bonding, conductive adhesives, ultrasonic bonding and wire bonding.

5 40. The method of claim 31 comprising the step of engaging the second ends of the electrical contact members with a second circuit member.

41. The method of claim 31 comprising the step of preparing at least one device site on the second surface of the housing.

10 42. A method of making an electrical interconnect for electrically coupling terminals on a flexible circuit member with terminals on a second circuit member, comprising the steps of:

15 providing a housing having a plurality of through holes extending between a first surface and a second surface, each of the through holes defining a central axis;

positioning a plurality of elongated electrical contact members in at least some of the through holes oriented along the central axes, the electrical contact members having first ends extending above the first surface; and

20 interposing a compliant encapsulating material between a portion of the through holes and a portion of the electrical contact members to control movement of the electrical contact members along their respective central axes.

1/19

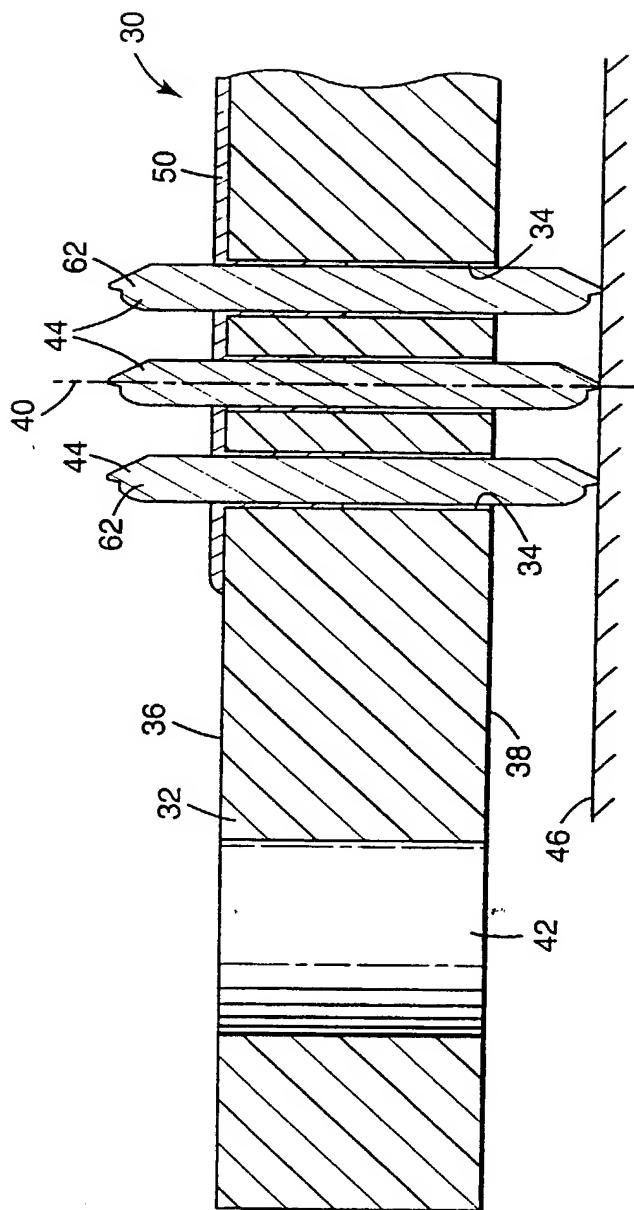
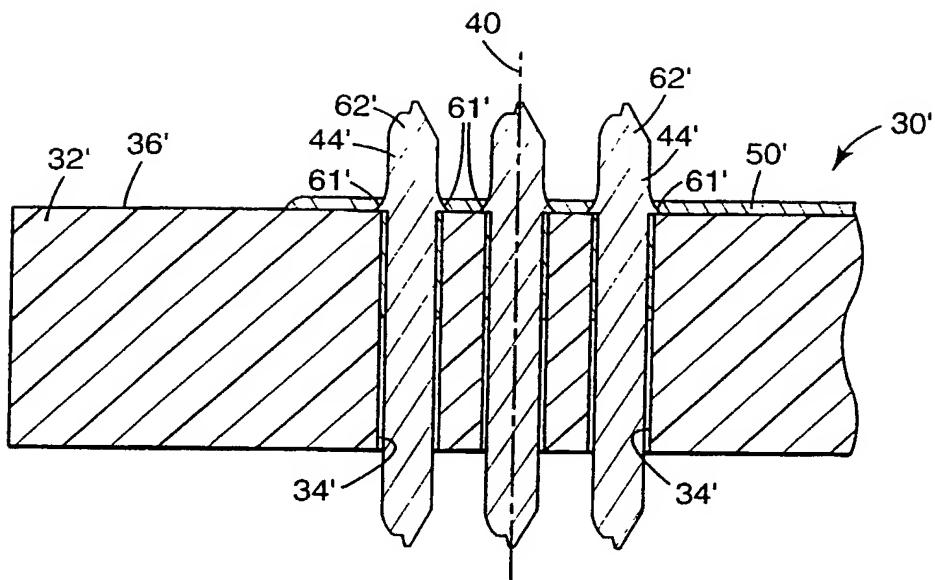
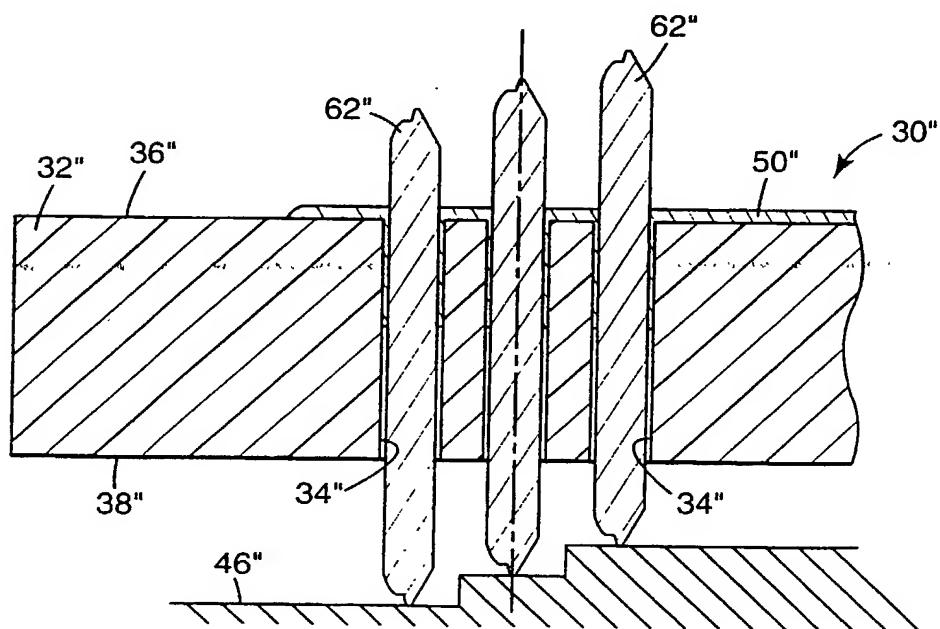


Fig. 1

2/19



*Fig. 1A*



*Fig. 1B*

3/19

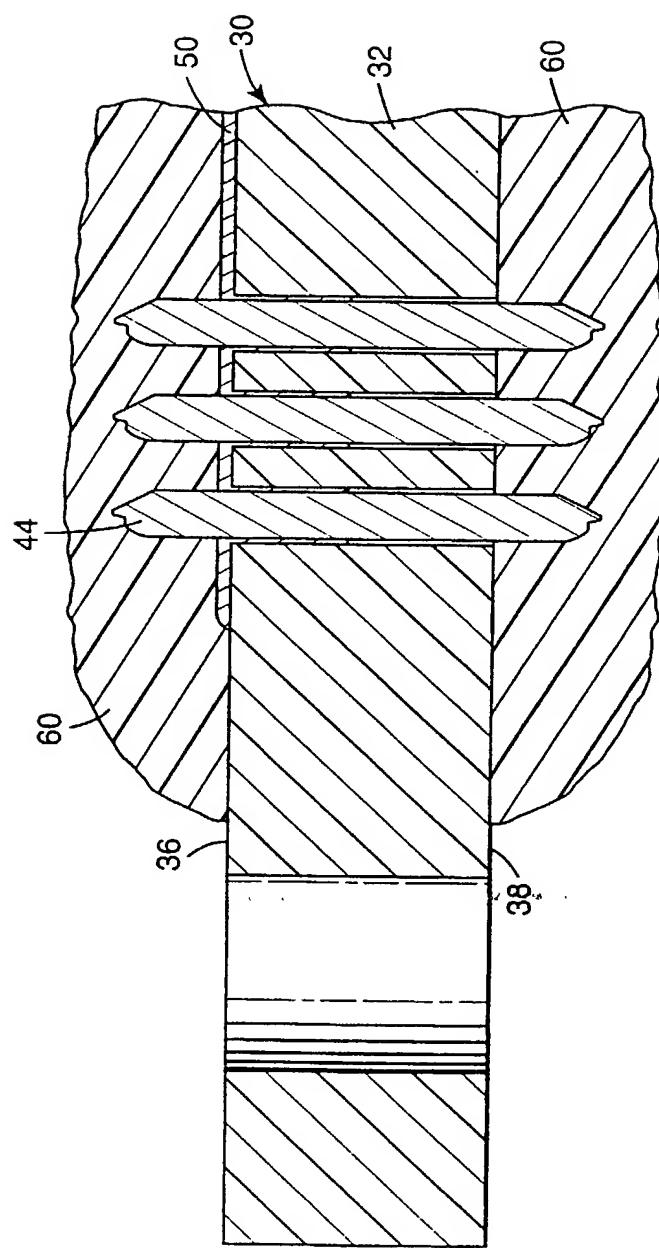


Fig. 2

4/19

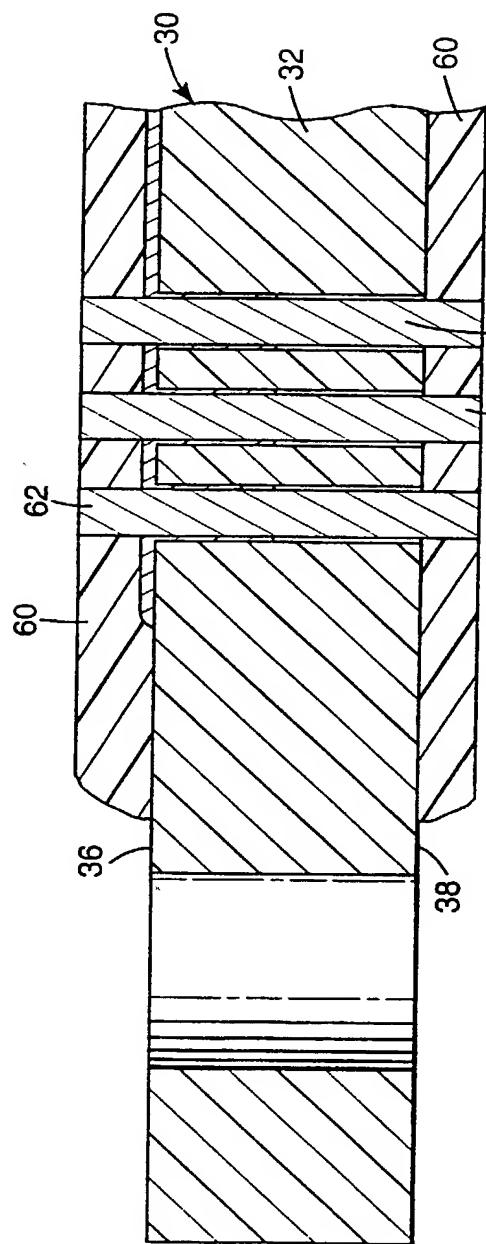


Fig. 3

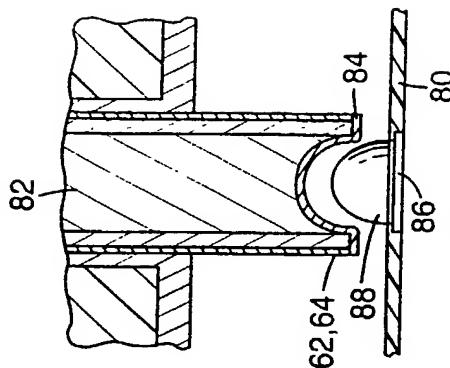


Fig. 4

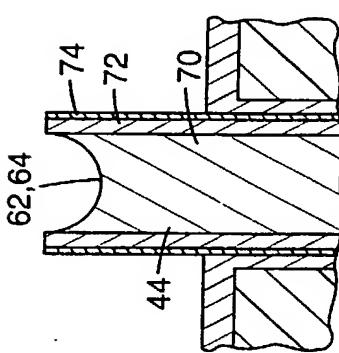


Fig. 5

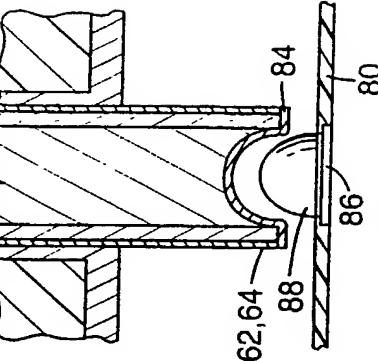


Fig. 6

5/19

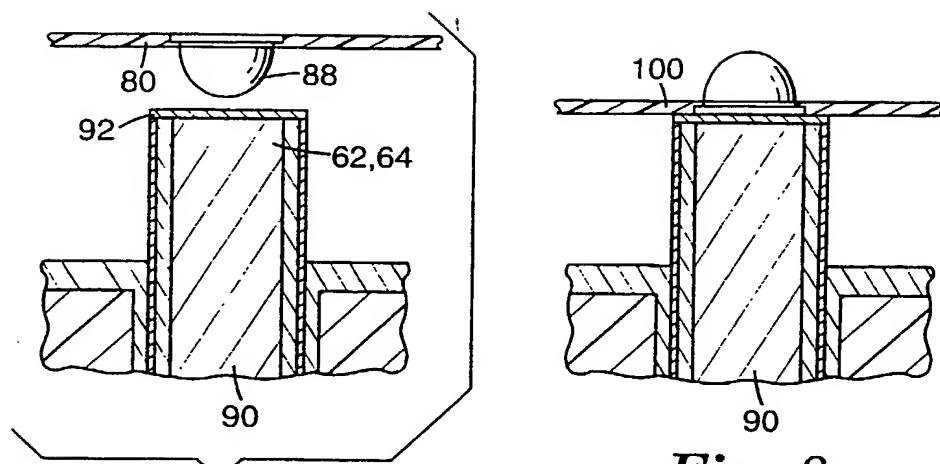


Fig. 7

Fig. 8

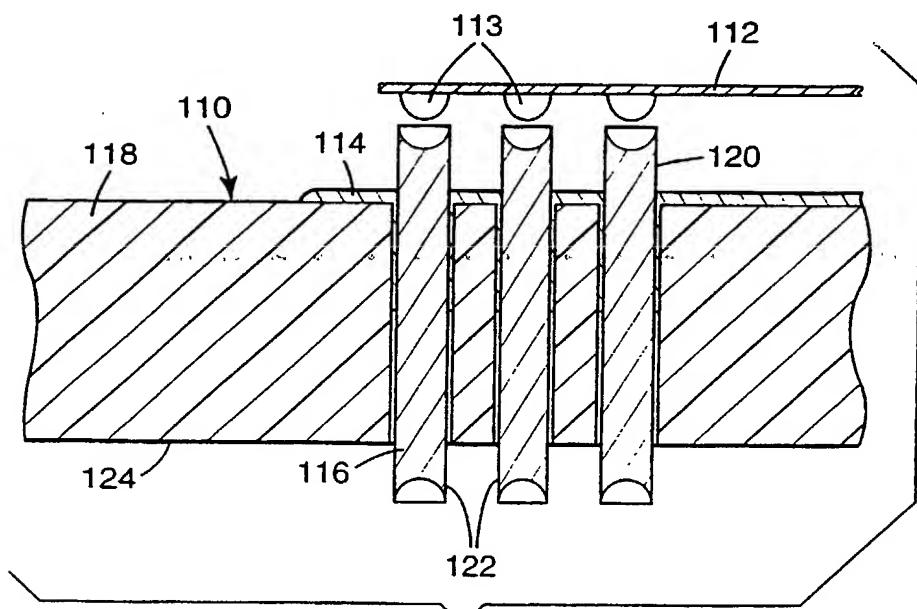
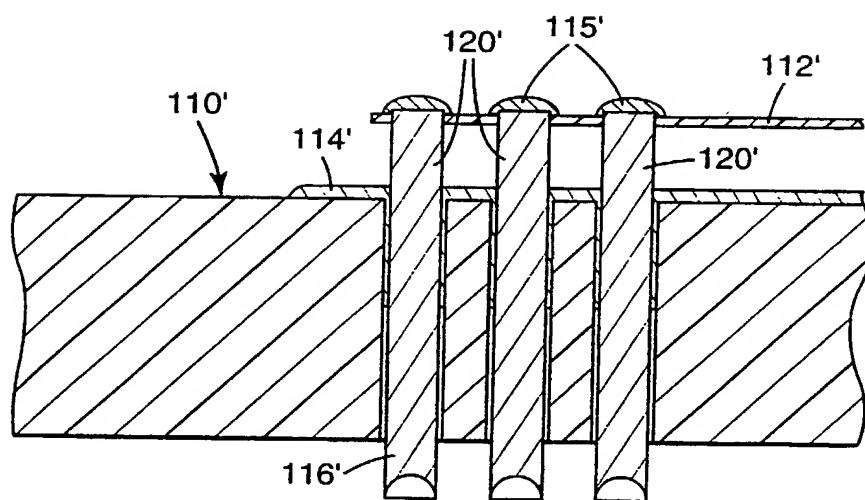


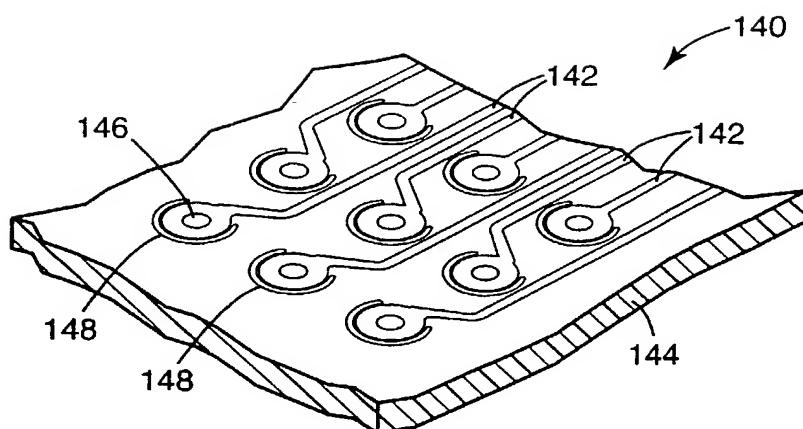
Fig. 9

6/19

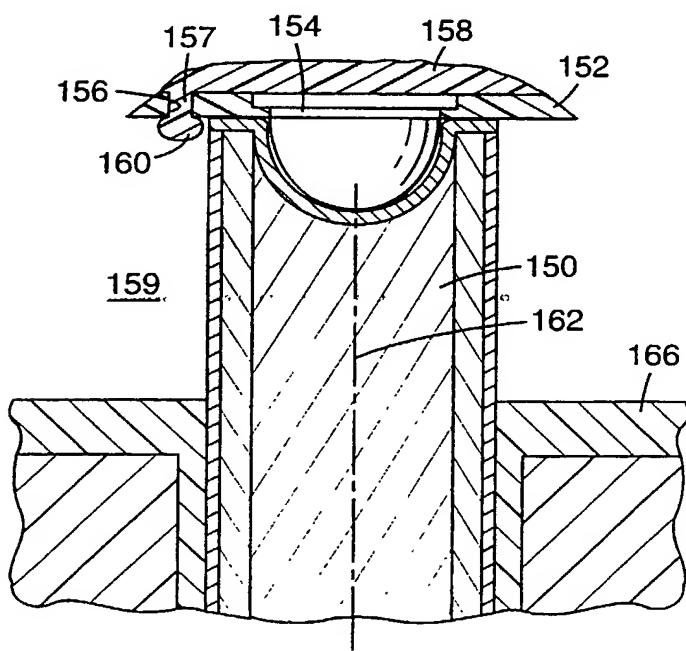


*Fig. 9A*

7/19

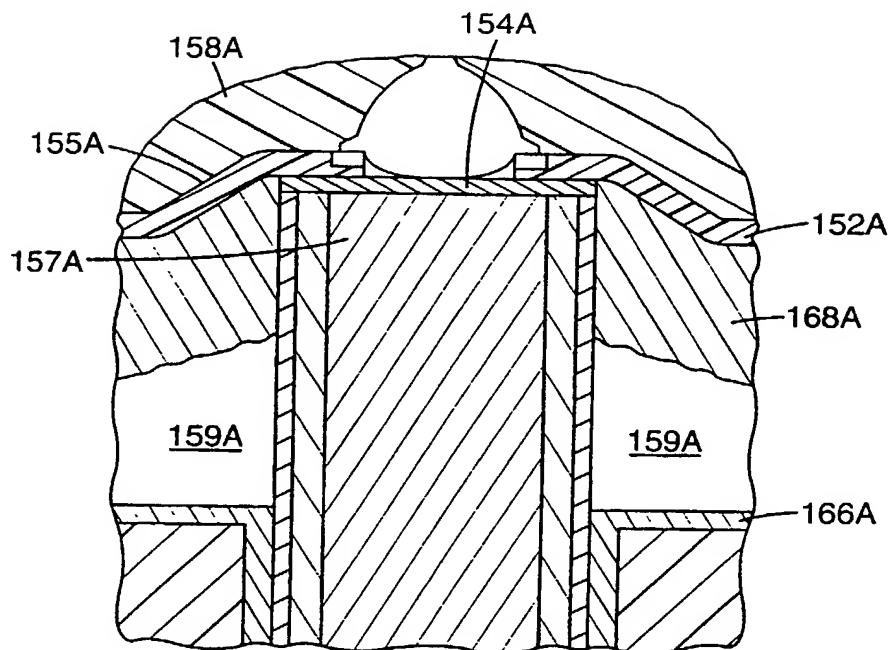


*Fig. 10*

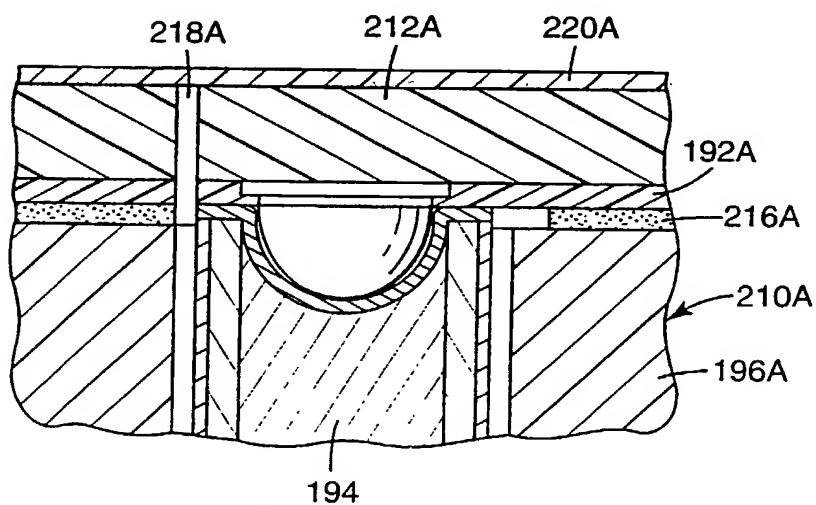


*Fig. 11*

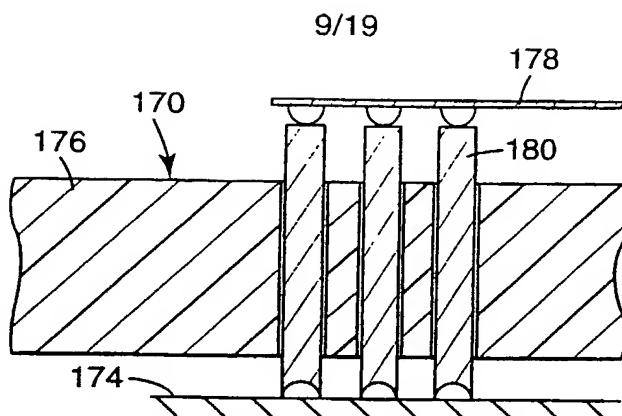
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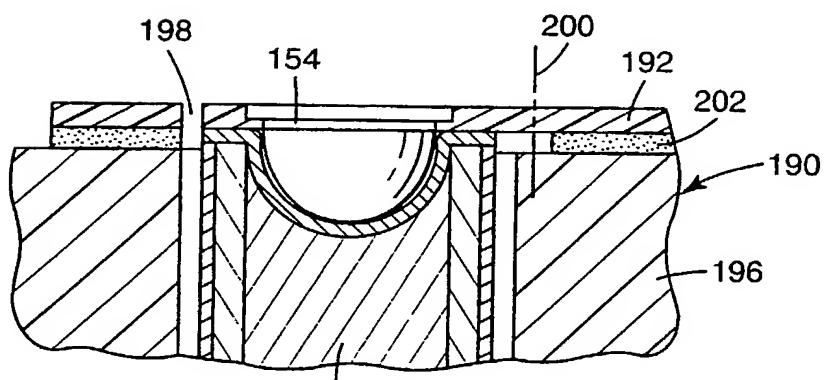
*Fig. 11A*



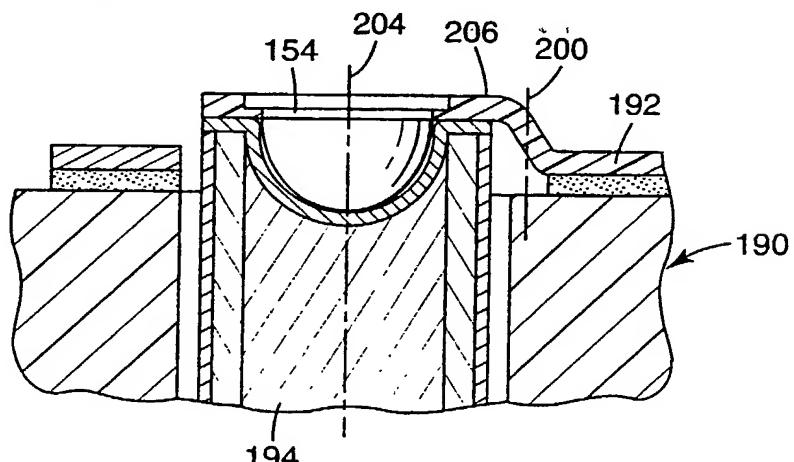
*Fig. 15A*



*Fig. 12*

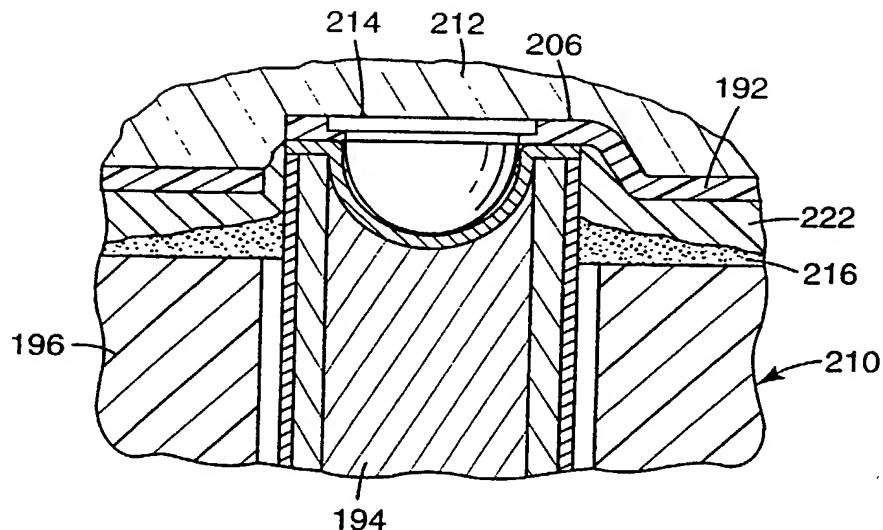


194  
*Fig. 13*

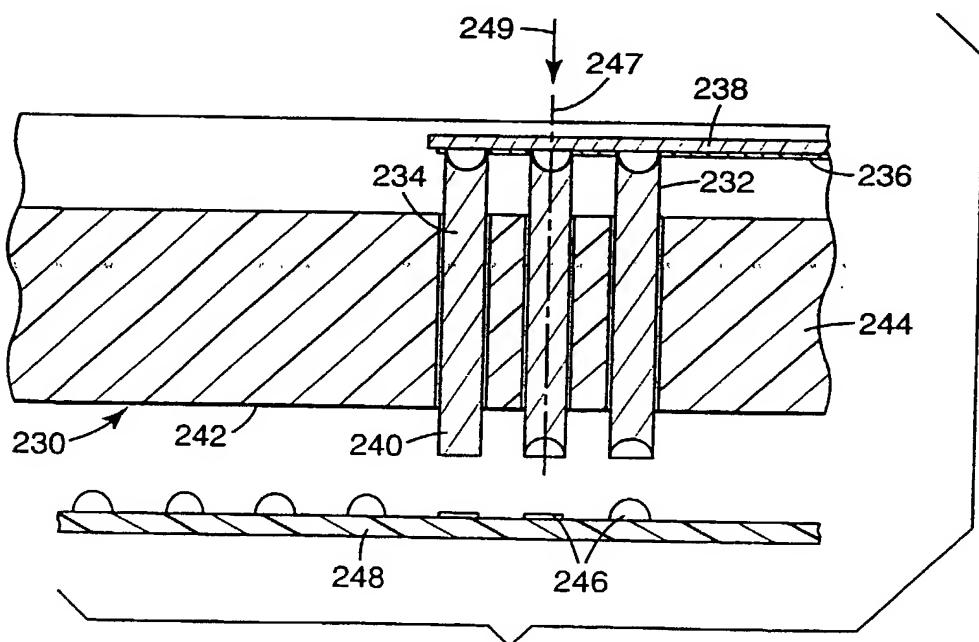


*Fig. 14*

10/19

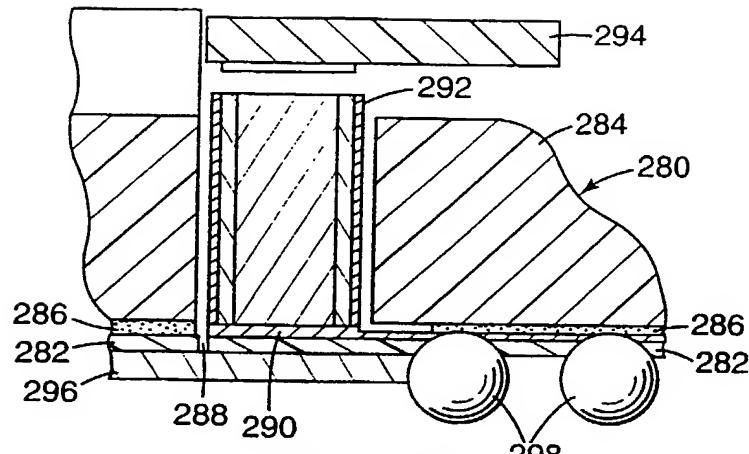


*Fig. 15*

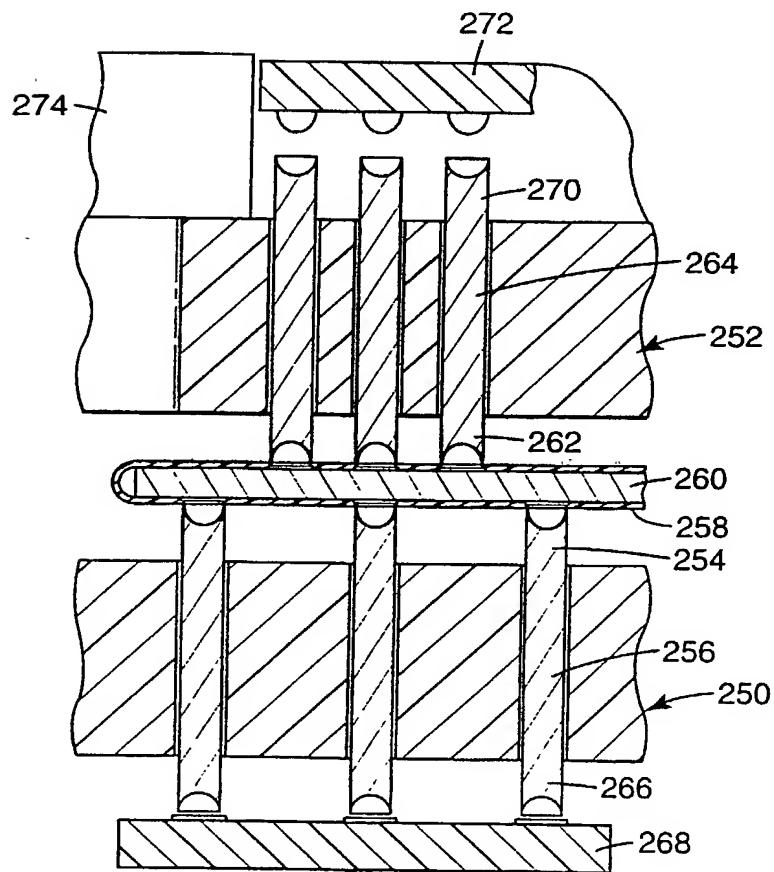


*Fig. 16*

11/19



*Fig. 17*



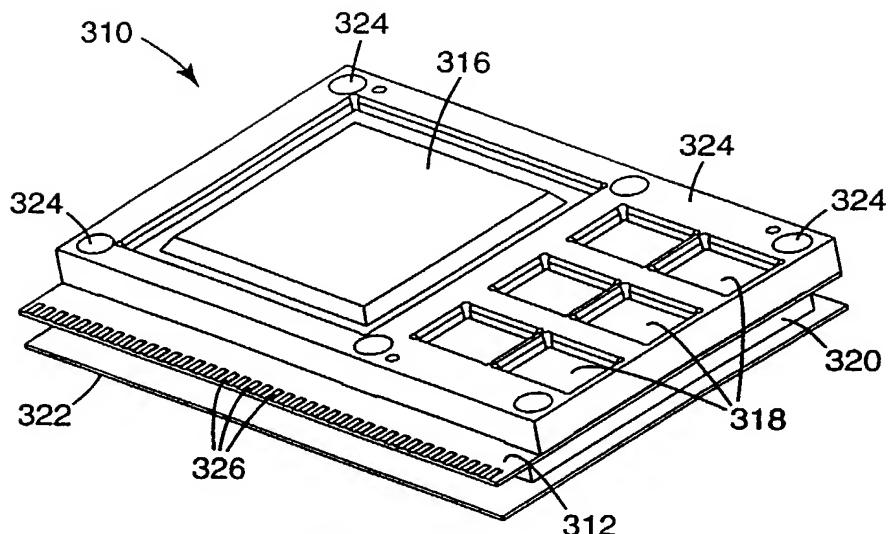
*Fig. 18*

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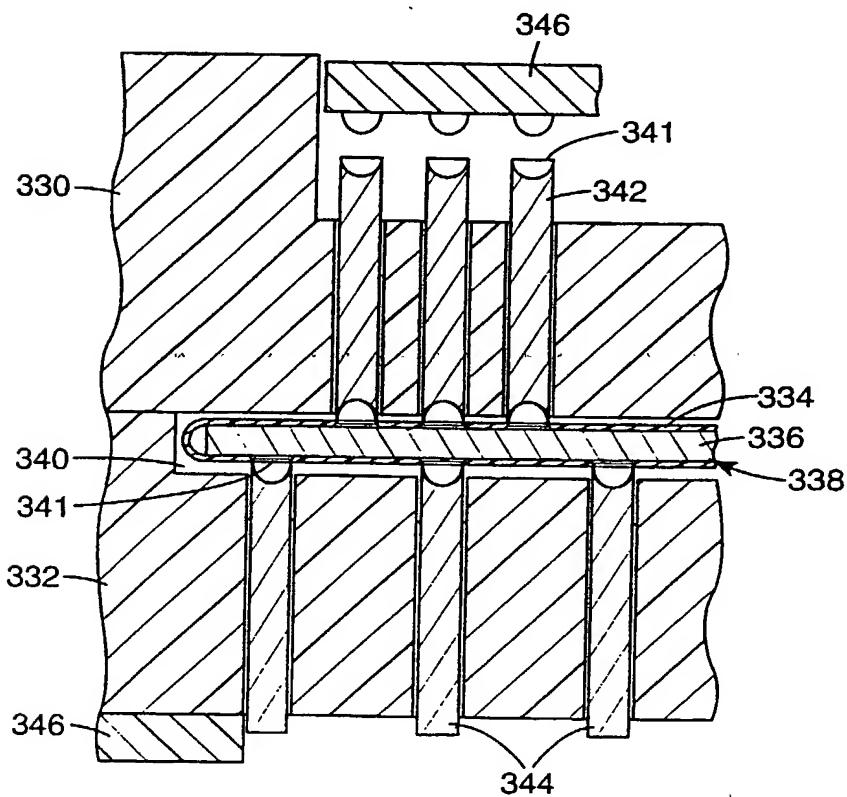
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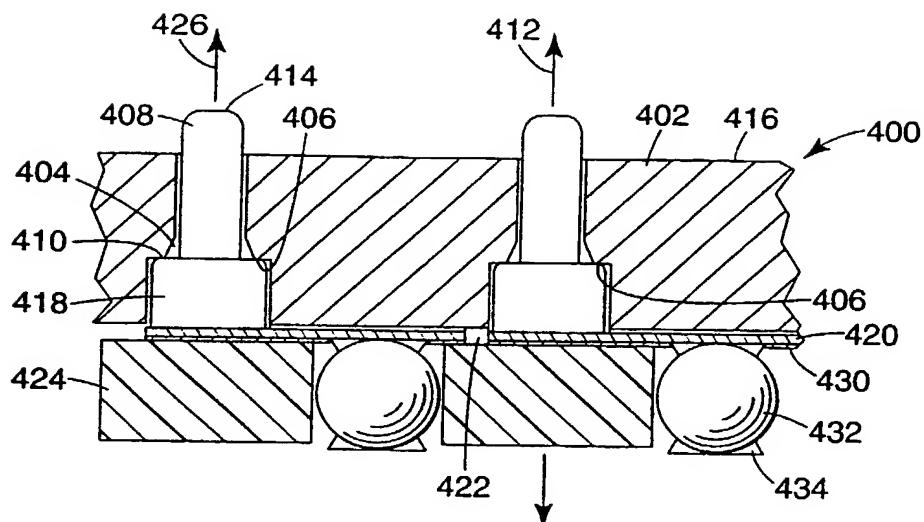


*Fig. 19*

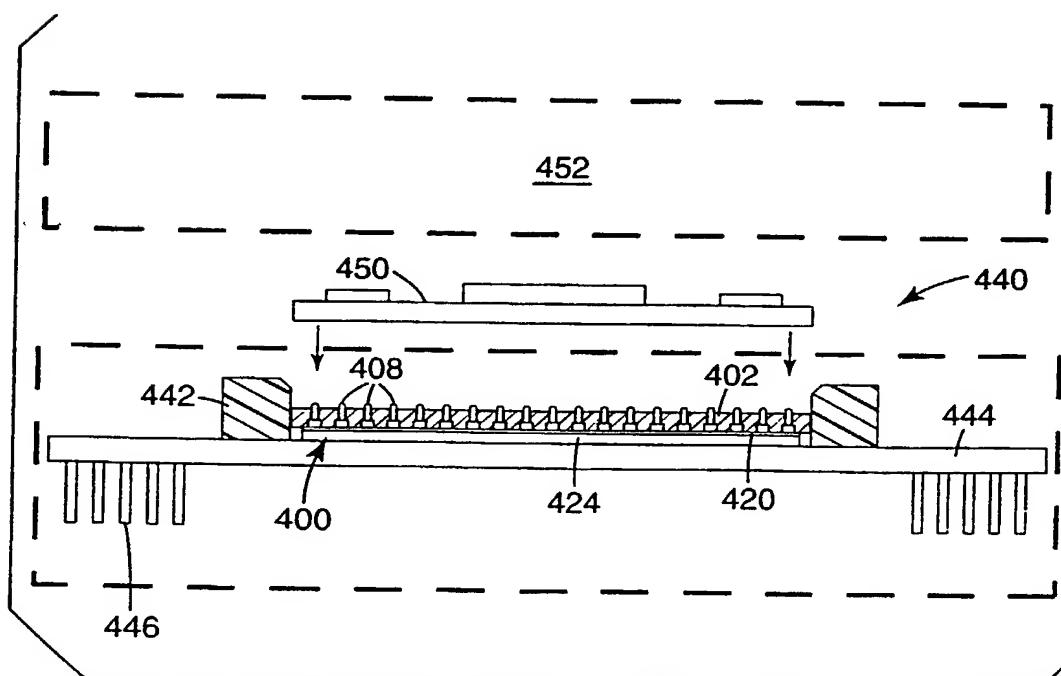


*Fig. 20*

13/19



*Fig. 21*



*Fig. 22*

14/19

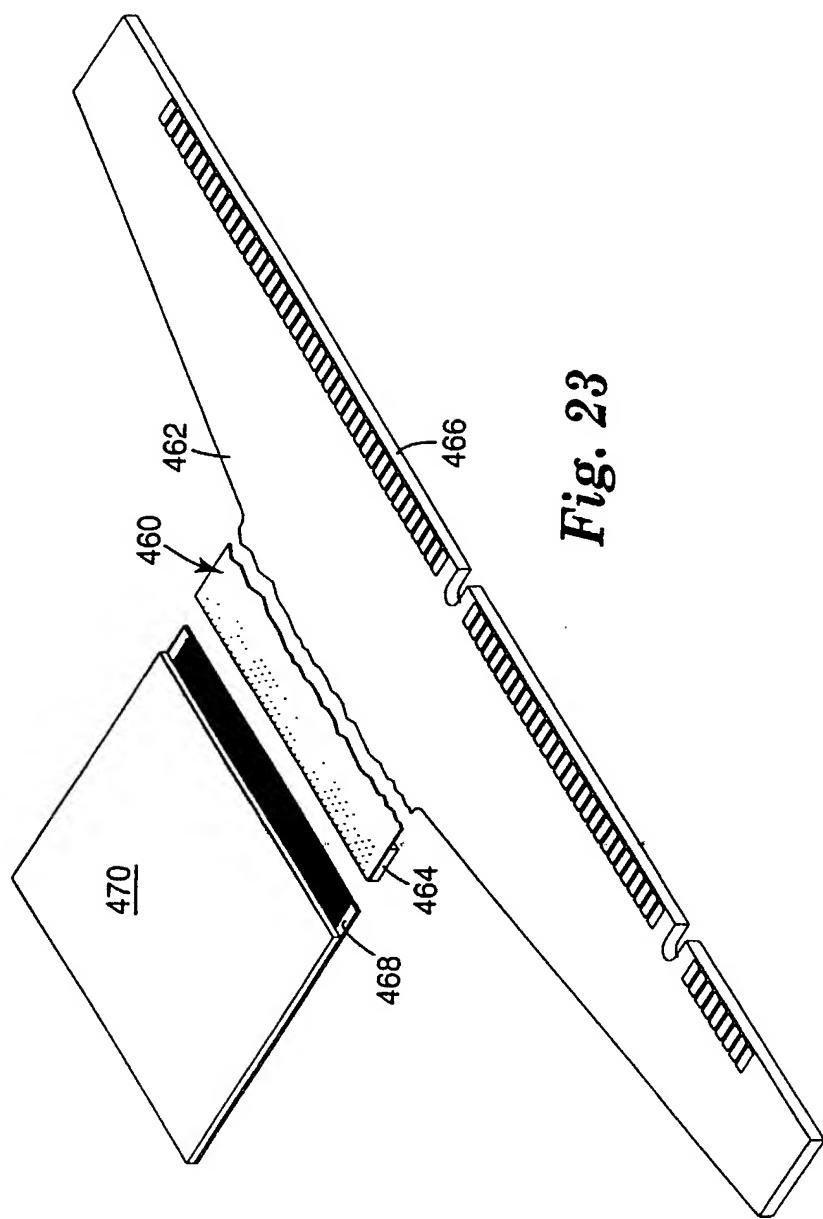
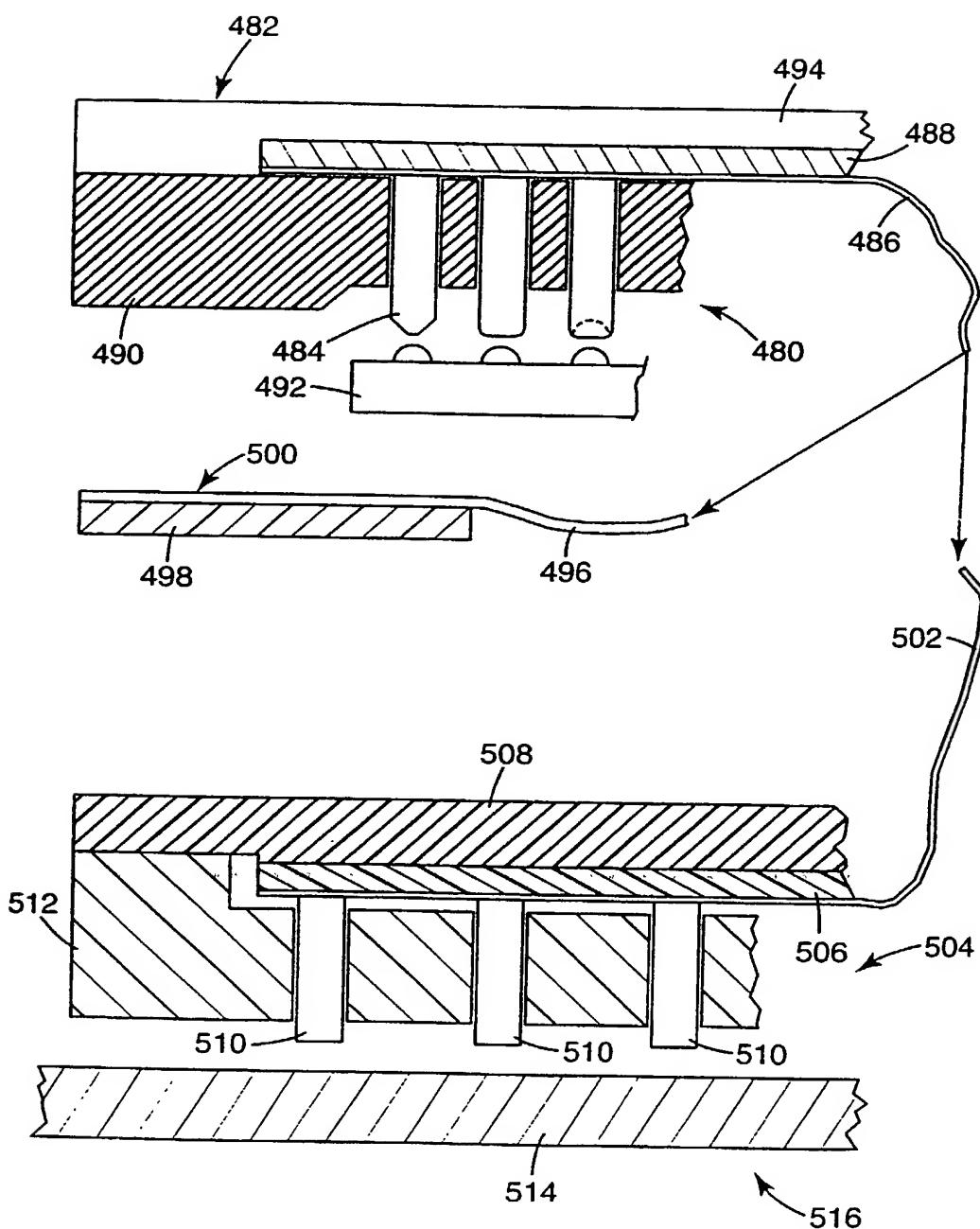


Fig. 23

15/19



*Fig. 24*

16/19

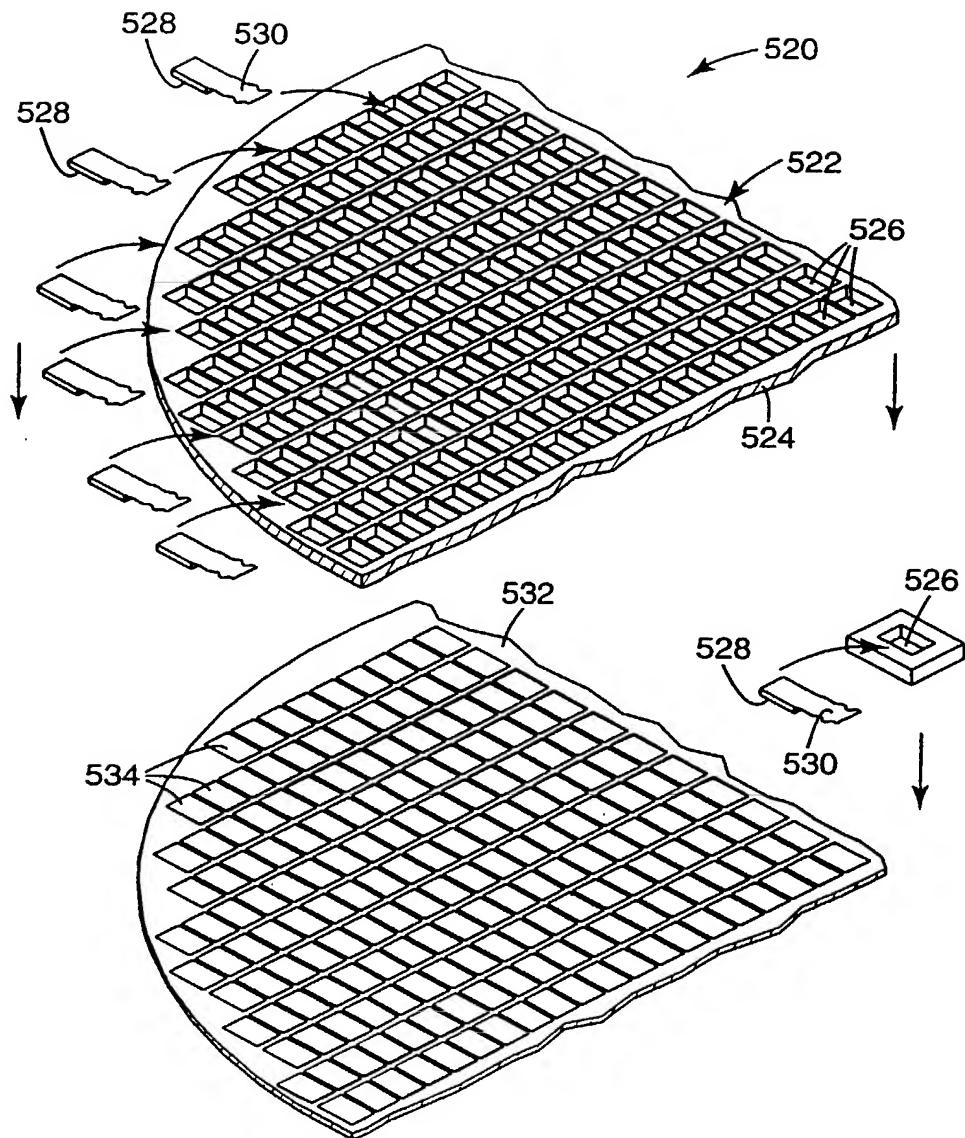


Fig. 25

17/19

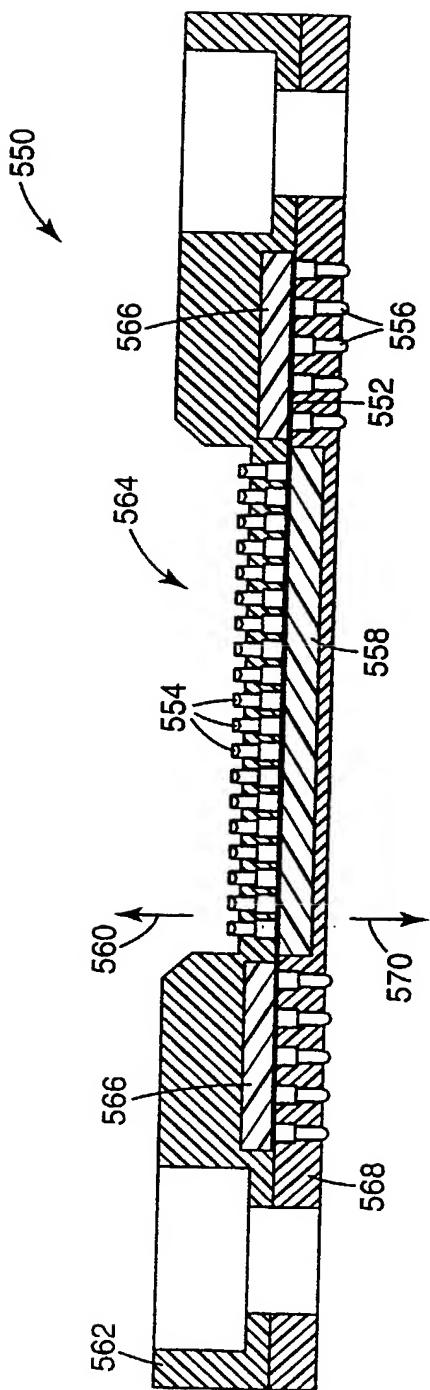
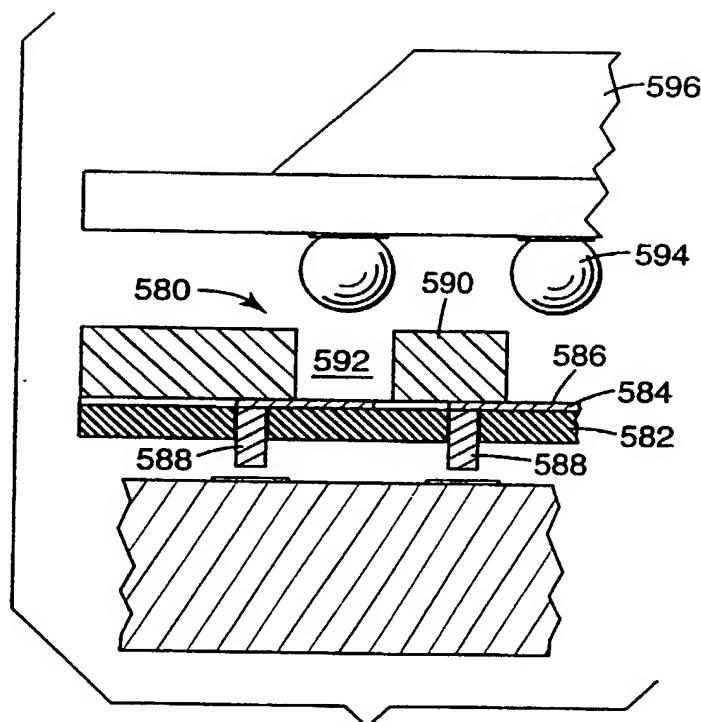
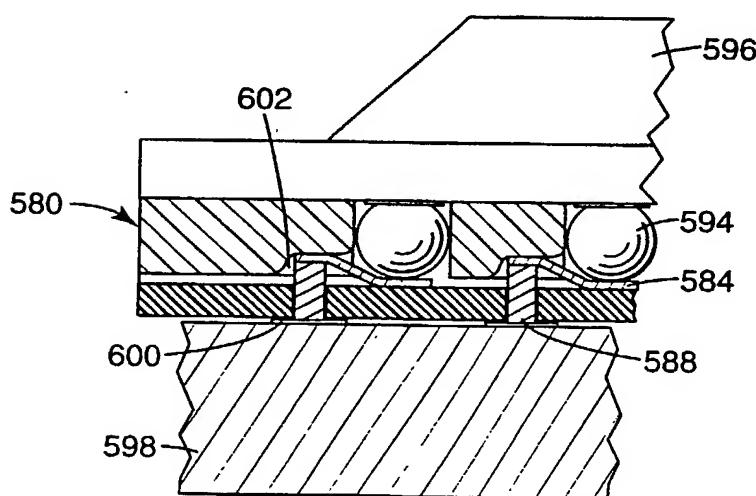


Fig. 26

18/19

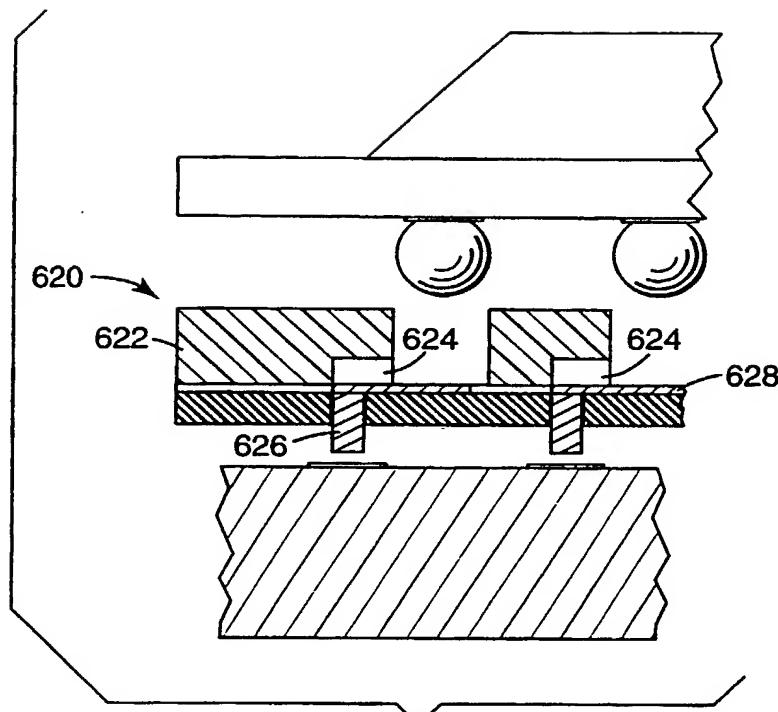


*Fig. 27A*

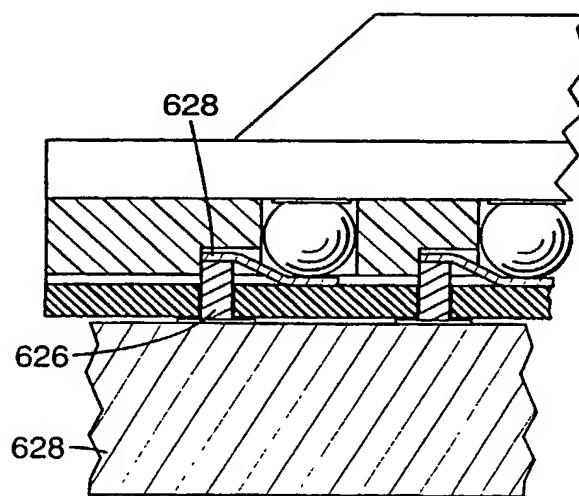


*Fig. 27B*

19/19



*Fig. 28A*



*Fig. 28B*

Attorney Docket No. 52191-243421

IN THE UNITED STATES ELECTED OFFICE (EO/US)

International Application No.	International Filing Date	Priority Date Claimed
PCT/US00/20748	31 July 2000	2 August 1999
Title of Invention		
CONTROLLED COMPLIANCE FINE PITCH INTERCONNECT		
Applicant		
Gryphics, Inc.		

**COMBINED DECLARATION AND  
POWER OF ATTORNEY IN ORIGINAL APPLICATION**

As a below-named inventor, I hereby declare that:

My residence, post office address and citizenship are as stated below next to my name.

I believe I am an original, first and joint inventor of the subject matter which is claimed and for which a patent is sought on the invention entitled CONTROLLED COMPLIANCE FINE PITCH INTERCONNECT, the specification of which was filed as PCT International Application No. PCT/US00/20748 on 31 July 2000, as amended by the Preliminary Amendment attached hereto.

I hereby state that I have reviewed and understand the contents of the above-identified specification, including the claims. I acknowledge the duty to disclose information which is material to patentability as defined in Title 37, Code of Federal Regulations, § 1.56. I hereby claim foreign priority benefits under Title 35, United States Code, § 119 of any foreign application(s) for patent or inventor's certificate listed below and have also identified below any foreign or PCT international application(s) for patent or inventor's certificate having a filing date before that of the application on which priority is claimed:

Prior Foreign Application(s)

Number	Country	Day/Month/Year Filed	Priority Claimed
PCT/US00/20748	WO	31 July 2000	Yes <input checked="" type="checkbox"/> No _____ Yes _____ No _____

I hereby claim the benefit under Title 35, United States Code, § 120 of any United States application(s) listed below and, insofar as the subject matter of each of the claims of this application is not disclosed in the prior United States application in the manner provided by the first paragraph of Title 35, United States Code, § 112, I acknowledge the duty to disclose material information as defined in Title 37, Code of Federal Regulations, § 1.56 which occurred between the filing date of the prior application and the national or PCT international filing date of this application:

Combined Declaration and Power of Attorney in Original Application  
Attorney Docket No. 52191-243421  
Page 2

Appln. Ser. No. 60/146,825 Filing Date August 2, 1999 Status: patented, pending abandoned  
abandoned

I hereby appoint the following attorneys and/or agents to prosecute this application and to transact all business in the Patent and Trademark Office connected therewith: Felicia J. Boyd, Reg. No. 32,683; Paul W. Busse, Reg. No. 32,403; Lynn C. Cameron, Reg. No. 44,581; John M. Haurykiewicz, Reg. No. 29,311; Robert B. Leonard, Reg. No. 33,946; Walter C. Linder, Reg. No. 31,707; Karl G. Schwappach, Reg. No. 35,786; William K. Weimer, Reg. No. 38,655; Gary S. Weinstein, Reg. No. 42,217; and Peter J. Georges, Reg. No. 25,867 (counsel's Washington, D. C. associate).

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I hereby declare that all statements made herein of my own knowledge are true and that all statements made on information and belief are believed to be true; and further that these statements were made with the knowledge that willful false statements and the like so made are punishable by fine or imprisonment, or both, under Section 1001 of Title 18 of the United States Code and that such willful false statements may jeopardize the validity of the application or any patent issued thereon.

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